



AVTECH ELECTROSYSTEMS LTD.

NANOSECOND WAVEFORM ELECTRONICS
SINCE 1975

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BOX 5120, LCD MERIVALE
OTTAWA, CANADA K2C3H5

INSTRUCTIONS

MODEL AVR-EB4-B

+2A / -4A REVERSE RECOVERY

MEASUREMENT SYSTEM

WITH 4.5 ns SWITCHING TIME

SERIAL NUMBER: 13985

WARRANTY

Avtech Electrosystems Ltd. warrants products of its manufacture to be free from defects in material and workmanship under conditions of normal use. If, within one year after delivery to the original owner, and after prepaid return by the original owner, this Avtech product is found to be defective, Avtech shall at its option repair or replace said defective item. This warranty does not apply to units which have been disassembled, modified or subjected to conditions exceeding the applicable specifications or ratings. This warranty is the extent of the obligation assumed by Avtech with respect to this product and no other warranty or guarantee is either expressed or implied.

TECHNICAL SUPPORT

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Last modified February 29, 2024.
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INTRODUCTION

The AVR-EB4-B is a high performance, GPIB and RS232-equipped instrument capable of generating a +100V / -200V bipolar waveform into a 50 Ohm resistance. Normally, a diode will be placed in series with this resistance, allowing diode currents of up to +2A and -4A to be generated.

More specifically, the AVR-EB4-B mainframe generates a 2-20 us wide forward-bias pulse with amplitude adjustable up to +100V/+2A, which is immediately followed by a 2-20 us wide reverse-bias pulse with amplitude up to -200V/-4A. The forward and reverse amplitudes and pulse widths are independently variable. The forward-to-reverse switching time is < 4.5 ns (10%-90%).

The current waveforms generated by this instrument are suitable for MIL-STD-750E Method 4031.4 Test Condition B tests. (Avtech can also provide separate test systems for Condition D tests). In the terminology of this standard, $V_3 = 0$ to +200V, $V_4 = 0$ to -200V, $R_F = 50$ Ohms, $R_4 = 50$ Ohms, and $R_R \approx 0$. These values differ from the values suggested in the standard, but the use of 50 Ohm resistances allows common coaxial cabling to be used for flexible connection arrangement, and greatly reduces the $\tau = L / R$ time constants that plague measurement systems based on the suggested values. As a result, the measurements are more accurate and more repeatable. (For additional information about the rationale behind the basic approach, please see Avtech Technical Brief 15, "A Comparison of Reverse Recovery Measurement Systems", at <http://www.avtechpulse.com/appnote>.)

The values of I_F , I_{RM} , and $i_{R(REC)}$ produced by this instrument are suitable for MIL-STD-750E Method 4031.4 Test Conditions B1-B4. (Condition B4 is not recommended by Avtech, however, because the high $I_{RM} / i_{R(REC)}$ ratio will make the results more sensitive to parasitic effects.)

Standard AVR-EB4-B models include one AVX-TRR-MIX diode test jig. The instrument mainframe is connected to the test jig using one coaxial cable and one DB-9 control cable. The standard test jig contains a variety of pin sockets and posts, which may be used to hold the diode device under test (DUT). The test jig has a hinged lid, which must be fully closed to protect the user from high voltages. The output will be automatically disabled if the lid is left open. The standard AVX-TRR-MIX test jig will accommodate TO-220AC (2 lead) packages, DO-style packages with (leads bent at 90°), and standard and reverse-polarity TO-3 packages.

The AVR-EB4-B may also be provided with different or additional a customized test jigs, to meet particular customer package requirements.

The diode-under-test is connected in series with a 50 Ohm resistance present on the test jig. In order to achieve the full +2A / -4A amplitude, the diode resistance (dV/dI at high currents) must be much less than 50 Ohms (i.e., 5 Ohms or lower).

One end of the 50 Ohm resistance is connected to ground, and access to the other end is provided through a coaxial connector. This output should be terminated with 50 Ohms, and connected to a high-bandwidth (> 400 MHz) oscilloscope. The voltage across this resistance is directly proportional to the current through the diode. By observing the current waveform through the diode, the reverse recovery time may be determined.

While the provided test jig is intended to be flexible and easy to use, users can also develop their own test jigs easily.

The AVR-EB4-B includes an internal trigger source, but it can also be triggered or gated by an external source. A front-panel pushbutton can also be used to trigger the instrument.

The AVR-EB4-B features front panel keyboard and adjust knob control of the output pulse parameters along with a four line by 40-character backlit LCD display of the output amplitude, pulse repetition frequency, and delay. The instrument includes memory to store up to four complete instrument setups. The operator may use the front panel or the computer interface to store a complete "snapshot" of all key instrument settings, and recall this setup at a later time.

This instrument is intended for use in research, development, test and calibration laboratories by qualified personnel.

SPECIFICATIONS

Model ¹ :	AVR-EB4-B	
Recovery type:	Reverse recovery	
Intended application:	High-speed rectifiers	
Basic waveform:	A positive pulse followed immediately by a negative pulse	
Pulse polarity:	-	+
Voltage output ^{2,4,6} : (to $R_L = 50\Omega$)	-2V to -200V	+5V to +100V
Corresponding diode current ^{2,4} (approx., depends on V_{DIODE}):	-40 mA to -4A	+100 mA to +2A
Pulse width (FWHM):	2 us - 20 us	
Rise time (10%-90%):	< 4.5 ns	< 1 us
Output impedance during pulse (inside the mainframe):	≤ 2 Ohm	50 Ohms
Maximum PRF:	100 Hz	
Variable delay (sync out to main out):	Follows + pulse	0 to ± 1 s, variable
Included test jig ³ :	See tables on later pages.	
Connectors:	BNC on mainframe, SMA on jigs	
GPIO & RS-232:	Standard on -B units. See http://www.avtechpulse.com/gpio for details.	
Ethernet port, for remote control using VXI-11.3, ssh, telnet, & web:	Optional ¹⁰ . Recommended as a modern alternative to GPIO / RS-232. See http://www.avtechpulse.com/options/vxi for details.	
Settings resolution:	The resolution of the timing parameters (pulse width, delay, period) varies, but is always better than 0.15% of (set value + 20 ns). The amplitude resolution is < 0.1% of the maximum amplitude.	
Settings accuracy:	Typically $\pm 3\%$ after 10 minute warmup, for timing parameter. For high-accuracy applications requiring traceable calibration, verify the output parameters with a calibrated oscilloscope ^{4,11} .	
Trigger modes:	Internal trigger, external trigger (TTL level pulse, > 10 ns, 1 k Ω input impedance), front-panel "Single Pulse" pushbutton, or single pulse trigger via computer command.	
Sync output:	> +3 Volts, > 50 ns, will drive 50 Ohm loads	
Gate input:	Active high or low, switchable. Suppresses triggering when active.	
Power requirements:	100 - 240 Volts, 50 - 60 Hz	
Dimensions:	H x W x D: 100 mm x 430 mm x 375 mm (3.9" x 17" x 14.8")	
Chassis material:	cast aluminum frame and handles, blue vinyl on aluminum cover plates	
Temperature range:	+5°C to +40°C	

- 1) -B suffix indicates IEEE-488.2 GPIO and RS-232 control of amplitude, pulse width, PRF and delay (see <http://www.avtechpulse.com/gpio>).
- 2) For operation at amplitudes of less than 10% of full-scale, best results will be obtained by setting the amplitude near full-scale and using external attenuators on the output.
- 3) Customized jigs available upon request.
- 4) The amplitude settings should not be relied upon for any degree of accuracy, because the dynamics of the device under test can affect the actual generated waveforms. Amplitude settings should always be verified by oscilloscope measurements.
- 5) Thus the diode must come to forward steady-state within 500 ns.
- 6) The diode must have a breakdown voltage exceeding these amplitude limits. Contact Avtech for special arrangements if $I_{MAX} \times 50\Omega > V_{BR}$.
- 7) The full forward pulse width is 2 us, but the reverse pulse is super-imposed on the forward pulse 500 ns after the start of the forward pulse.
- 8) Increases to 4.5 ns for units with the -DIPFP option, due to the switching relay inductance.
- 9) Depends on the parasitic inductance of the DUT and its leads.
- 10) Add the suffix -VXI to the model number to specify the Ethernet port.
- 11) These instruments are provided with a basic calibration checksheet, showing a selection of measured output parameters. These measurements are performed with equipment that is calibrated on a regular basis by a third-party ISO/IEC 17025:2005 accredited calibration laboratory. However, Avtech itself does not claim any accreditation. For applications requiring traceable performance, use a calibrated measurement system rather than relying on the accuracy of the pulse generator settings.

REGULATORY NOTES

FCC PART 18

This device complies with part 18 of the FCC rules for non-consumer industrial, scientific and medical (ISM) equipment.

This instrument is enclosed in a rugged metal chassis and uses a filtered power entry module (where applicable). The main output signal is provided on a shielded connector that is intended to be used with shielded coaxial cabling and a shielded load. Under these conditions, the interference potential of this instrument is low.

If interference is observed, check that appropriate well-shielded cabling is used on the output connectors. Contact Avtech (info@avtechpulse.com) for advice if you are unsure of the most appropriate cabling. Also, check that your load is adequately shielded. It may be necessary to enclose the load in a metal enclosure.

If any of the connectors on the instrument are unused, they should be covered with shielded metal "dust caps" to reduce the interference potential.

This instrument does not normally require regular maintenance to minimize interference potential. However, if loose hardware or connectors are noted, they should be tightened. Contact Avtech (info@avtechpulse.com) if you require assistance.

EC DECLARATION OF CONFORMITY



We Avtech Electrosystems Ltd.
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 Ottawa, Ontario
 Canada K2C 3H5

declare that this pulse generator meets the intent of Directive 2004/108/EG for Electromagnetic Compatibility. Compliance pertains to the following specifications as listed in the official Journal of the European Communities:

EN 50081-1 Emission

EN 50082-1 Immunity

and that this pulse generator meets the intent of the Low Voltage Directive 2006/95/EC. Compliance pertains to the following specifications as listed in the official Journal of the European Communities:

EN 61010-1:2001 Safety requirements for electrical equipment for measurement, control, and laboratory use

DIRECTIVE 2011/65/EU (RoHS)

We Avtech Electrosystems Ltd.
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Ottawa, Ontario
Canada K2C 3H5

declare that, to the best of our knowledge, all electrical and electronic equipment (EEE) sold by the company are in compliance with Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (also known as “RoHS Recast”). In addition, this declaration of conformity is issued under the sole responsibility of Avtech Electrosystems Ltd. Specifically, products manufactured do not contain the substances listed in the table below in concentrations greater than the listed maximum value.

<i>Material/Substance</i>	<i>Threshold level</i>
Lead (Pb)	< 1000 ppm (0.1% by mass)
Mercury (Hg)	< 1000 ppm (0.1% by mass)
Hexavalent Chromium (Cr6+)	< 1000 ppm (0.1% by mass)
Polybrominated Biphenyls (PBB)	< 1000 ppm (0.1% by mass)
Polybrominated Diphenyl ethers (PBDE)	< 1000 ppm (0.1% by mass)
Cadmium (Cd)	< 100 ppm (0.01% by mass)
Bis(2-ethylhexyl) phthalate (DEHP)	< 1000 ppm (0.1% by mass)
Butyl benzyl phthalate (BBP)	< 1000 ppm (0.1% by mass)
Dibutyl phthalate (DBP)	< 1000 ppm (0.1% by mass)
Diisobutyl phthalate (DIBP)	< 1000 ppm (0.1% by mass)

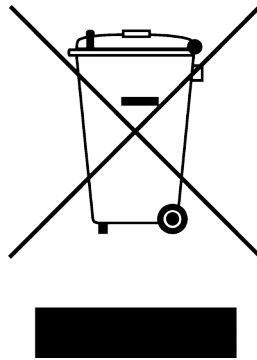
DIRECTIVE 2002/96/EC (WEEE)

European customers who have purchased this equipment directly from Avtech will have completed a “WEEE Responsibility Agreement” form, accepting responsibility for WEEE compliance (as mandated in Directive 2002/96/EC of the European Union and local

laws) on behalf of the customer, as provided for under Article 9 of Directive 2002/96/EC.

Customers who have purchased Avtech equipment through local representatives should consult with the representative to determine who has responsibility for WEEE compliance. Normally, such responsibilities will lie with the representative, unless other arrangements (under Article 9) have been made.

Requirements for WEEE compliance may include registration of products with local governments, reporting of recycling activities to local governments, and financing of recycling activities.



FIRMWARE LICENSING

Instruments with firmware versions 5.00 or higher use open-source software internally. Some of this software requires that the source code be made available to the user as a condition of its licensing. This source code is available upon request (contact info@avtechpulse.com).

Earlier firmware versions do not contain any open source software.

INSTALLATION

VISUAL CHECK

After unpacking the instrument, examine to ensure that it has not been damaged in shipment. Visually inspect all connectors, knobs, liquid crystal displays (LCDs), and the handles. If the instrument has been damaged, file a claim immediately with the company that transported the instrument.

The following items should be with the instrument:

1. One power cord.
2. One GPIB cable
3. Two instrumentation manuals (this manual and the "Programming Manual for -B Instruments").
4. One test jig, with a hinged lid.
5. One 5 meter length of coaxial cable.
6. One 60 cm length of coaxial cable.
7. One 50 Ohm BNC feed-through terminator
8. One 2 meter DB-9 control cable.

POWER RATINGS


This instrument is intended to operate from 100 - 240 V, 50 - 60 Hz.

The maximum power consumption is 57 Watts. Please see the "FUSES" section for information about the appropriate AC and DC fuses.

This instrument is an "Installation Category II" instrument, intended for operation from a normal single-phase supply.

CONNECTION TO THE POWER SUPPLY


An IEC-320 three-pronged recessed male socket is provided on the back panel for AC power connection to the instrument. One end of the detachable power cord that is supplied with the instrument plugs into this socket. The other end of the detachable power cord plugs into the local mains supply. Use only the cable supplied with the instrument. The mains supply must be earthed, and the cord used to connect the instrument to the mains supply must provide an earth connection. (The supplied cord does this.)

 **Warning:** Failure to use a grounded outlet may result in injury or death due to electric shock. This product uses a power cord with a ground connection. It must be connected to a properly grounded outlet. The instrument chassis is connected to the ground wire in the power cord.

The table below describes the power cord that is normally supplied with this instrument, depending on the destination region:

Destination Region	Description	Option	Manufacturer	Part Number
United Kingdom, Hong Kong, Singapore, Malaysia	BS 1363, 230V, 50 Hz	-AC00	Qualtek	370001-E01
Australia, New Zealand	AS 3112:2000, 230-240V, 50 Hz	-AC01	Qualtek	374003-A01
Continental Europe, Korea, Indonesia, Russia	European CEE 7/7 "Schuko" 230V, 50 Hz	-AC02	Qualtek	364002-D01
North America, Taiwan	NEMA 5-15, 120V, 60 Hz	-AC03	Qualtek	312007-01
Switzerland	SEV 1011, 230V, 50 Hz	-AC06	Qualtek	378001-E01
South Africa, India	SABS 164-1, 220-250V, 50 Hz	-AC17	Volex	2131H 10 C3
Japan	JIS 8303, 100V, 50-60 Hz	-AC18	Qualtek	397002-01
Israel	SI 32, 220V, 50 Hz	-AC19	Qualtek	398001-01
China	GB 1002-1 / 2099-1, 220V, 50 Hz	-AC22	Qualtek	399012-01

PROTECTION FROM ELECTRIC SHOCK

 Operators of this instrument must be protected from electric shock at all times. The owner must ensure that operators are prevented access and/or are insulated from every connection point. In some cases, connections must be exposed to potential human contact. Operators must be trained to protect themselves from the risk of electric shock. This instrument is intended for use by qualified personnel who recognize shock hazards and are familiar with safety precautions required to avoid possibly injury. In particular, operators should:

1. Keep exposed high-voltage wiring to an absolute minimum.
2. Wherever possible, use shielded connectors and cabling.
3. Connect and disconnect loads and cables only when the instrument is turned off.
4. Keep in mind that all cables, connectors, oscilloscope probes, and loads must have an appropriate voltage rating.
5. Do not attempt any repairs on the instrument, beyond the fuse replacement procedures described in this manual. Contact Avtech technical support (see page 2 for contact information) if the instrument requires servicing. Service is to be performed solely by qualified service personnel.

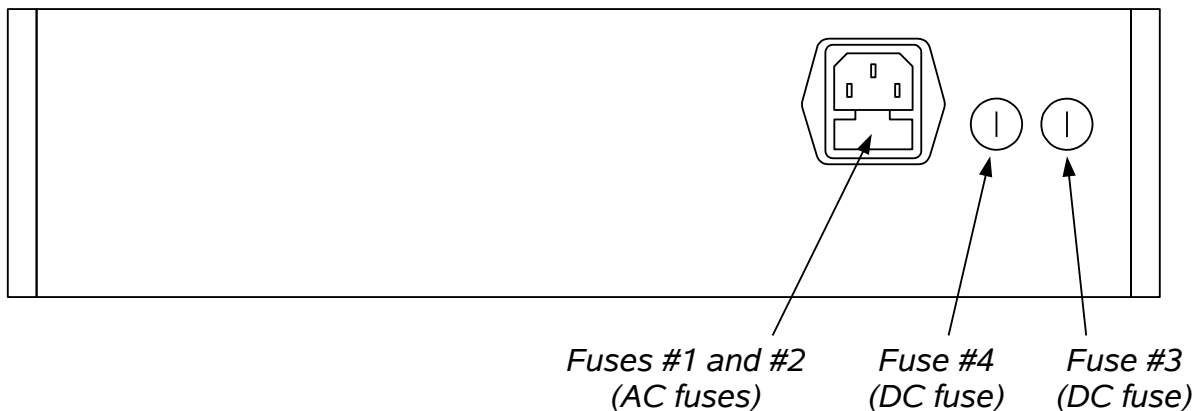
ENVIRONMENTAL CONDITIONS

This instrument is intended for use under the following conditions:

1. indoor use;
2. altitude up to 2 000 m;
3. temperature 5 °C to 40 °C;
4. maximum relative humidity 80 % for temperatures up to 31 °C decreasing linearly to 50 % relative humidity at 40 °C;
5. Mains supply voltage fluctuations up to ± 10 % of the nominal voltage;
6. no pollution or only dry, non-conductive pollution.

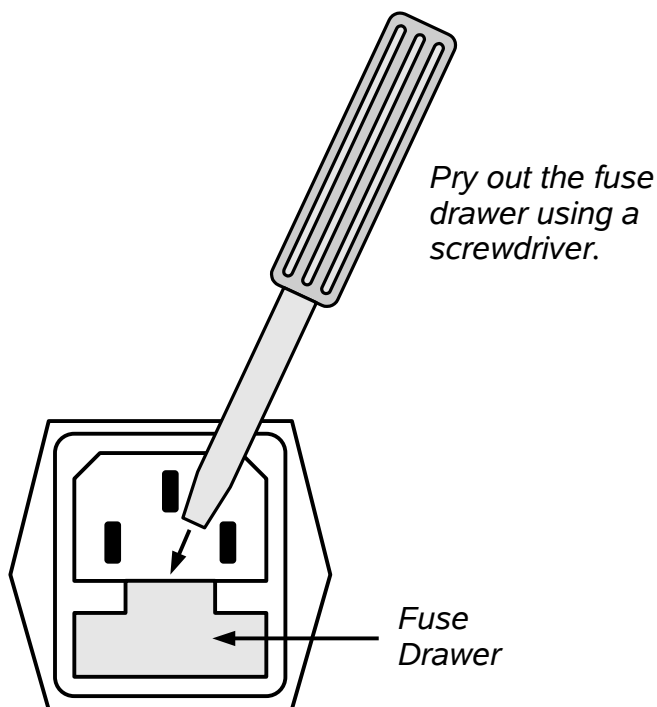
FUSES

This instrument contains four fuses. All are accessible from the rear-panel. Two protect the AC prime power input, and two protect the internal DC power supplies. The locations of the fuses on the rear panel are shown in the figure below:



AC FUSE REPLACEMENT

To physically access the AC fuses, the power cord must be detached from the rear panel of the instrument. The fuse drawer may then be extracted using a small flat-head screwdriver, as shown below:



DC FUSE REPLACEMENT

The DC fuses may be replaced by inserting the tip of a flat-head screwdriver into the fuse holder slot, and rotating the slot counter-clockwise. The fuse and its carrier will then pop out.

FUSE RATINGS

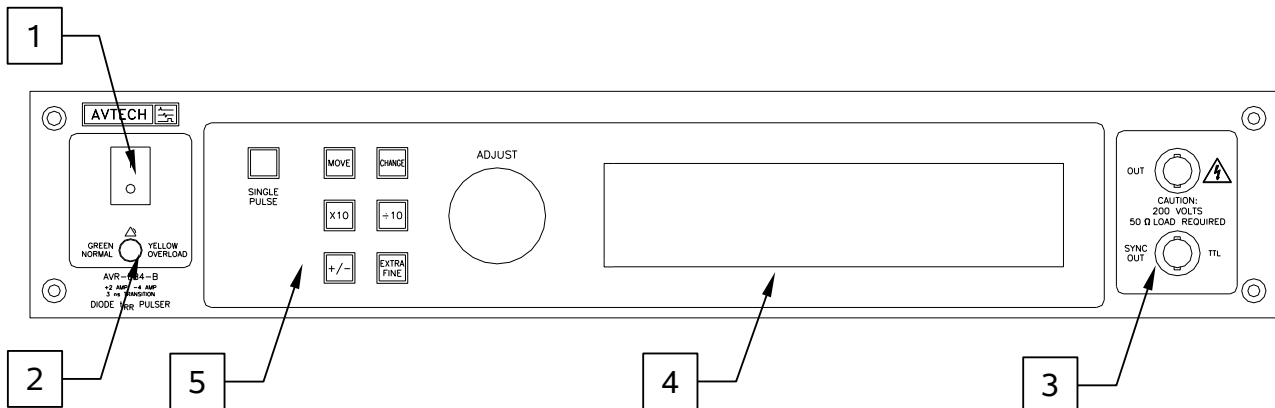
The following table lists the required fuses:

Fuses	Nominal Mains Voltage	Rating	Case Size	Recommended Replacement Part	
				Littelfuse Part Number	Digi-Key Stock Number
#1, #2 (AC)	100-240V	0.5A, 250V, Time-Delay	5×20 mm	0218.500HXP	F2416-ND
#3 (DC)	N/A	1.6A, 250V, Time-Delay	5×20 mm	021801.6HXP	F2424-ND
#4 (DC)	N/A	0.8A, 250V, Time-Delay	5×20 mm	0218.800HXP	F2418-ND

The recommended fuse manufacturer is Littelfuse (<http://www.littelfuse.com>).

Replacement fuses may be easily obtained from Digi-Key (<http://www.digikey.com>) and other distributors.

FRONT PANEL CONTROLS



1. **POWER Switch.** This is the main power switch. When turning the instrument on, there is normally a delay of 10 seconds before anything is shown on the main display, as the internal operating system boots up.

If the main menu does not appear after 30 seconds, turn off the instrument and leave it off for at least 60 seconds before applying power again.

2. **OVERLOAD Indicator.** When the instrument is powered, this indicator is normally green, indicating normal operation. If this indicator is yellow, an internal automatic overload protection circuit has been tripped. If the unit is overloaded (by operating at an exceedingly high duty cycle or by operating into a very low impedance), the protective circuit will disable the output of the instrument and turn the indicator light yellow. The light will stay yellow (i.e. output disabled) for about 5 seconds after which the instrument will attempt to re-enable the output (i.e. light green) for about 1 second. If the overload condition persists, the output will be disabled again (i.e. light yellow) for another 5 seconds. If the overload condition has been removed, the instrument will resume normal operation.

This overload indicator may flash yellow briefly at start-up. This is not a cause for concern.

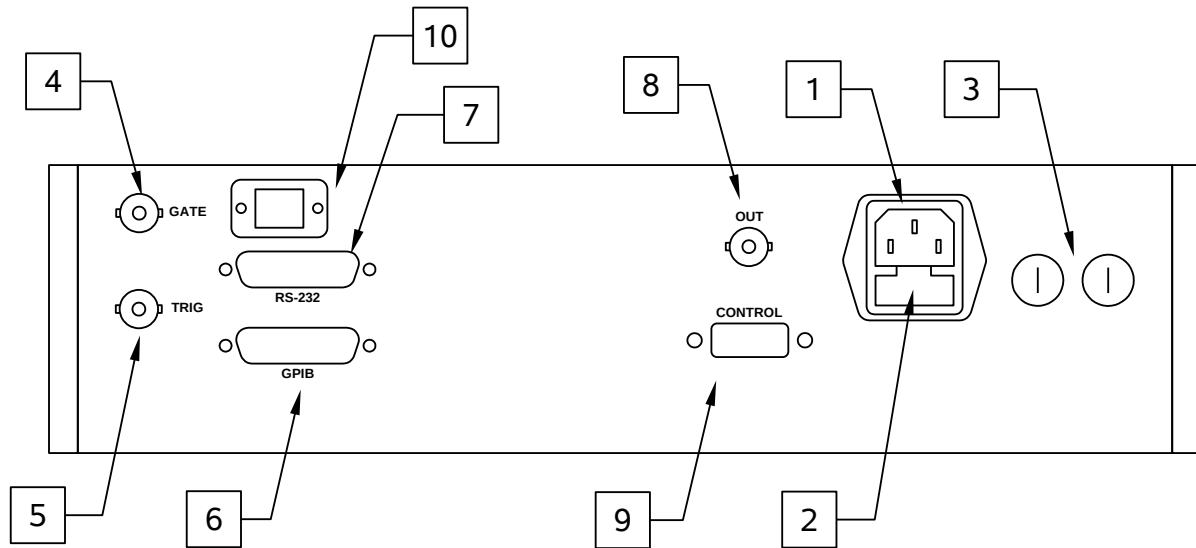
3. **SYNC OUT.** This connector supplies a SYNC output that can be used to trigger other equipment, particularly oscilloscopes. This signal leads (or lags) the main output by a duration set by the "DELAY" controls and has an approximate amplitude of +3 Volts to $R_L > 50\Omega$ with a pulse width of approximately 100 ns.
4. **LIQUID CRYSTAL DISPLAY (LCD).** This LCD is used in conjunction with the keypad to change the instrument settings. Normally, the main menu is displayed, which lists the key adjustable parameters and their current values. The "Programming Manual for -B Instruments" describes the menus and submenus in

detail.

5. KEYPAD.

Control Name	Function
MOVE	This moves the arrow pointer on the display.
CHANGE	This is used to enter the submenu, or to select the operating mode, pointed to by the arrow pointer.
×10	If one of the adjustable numeric parameters is displayed, this increases the setting by a factor of ten.
÷10	If one of the adjustable numeric parameters is displayed, this decreases the setting by a factor of ten.
+/-	If one of the adjustable numeric parameters is displayed, and this parameter can be both positive or negative, this changes the sign of the parameter.
EXTRA FINE	This changes the step size of the ADJUST knob. In the extra-fine mode, the step size is twenty times finer than in the normal mode. This button switches between the two step sizes.
ADJUST	This large knob adjusts the value of any displayed numeric adjustable values, such as frequency, pulse width, etc. The adjust step size is set by the "EXTRA FINE" button. When the main menu is displayed, this knob can be used to move the arrow pointer.

REAR PANEL CONTROLS




Note: some connectors may be in different positions than shown above, depending on the exact combination of options ordered.

1. **AC POWER INPUT.** An IEC-320 C14 three-pronged recessed male socket is provided on the back panel for AC power connection to the instrument. One end of the detachable power cord that is supplied with the instrument plugs into this socket.
2. **AC FUSE DRAWER.** The two fuses that protect the AC input are located in this drawer. Please see the “FUSES” section of this manual for more information.
3. **DC FUSES.** These two fuses protect the internal DC power supplies. Please see the “FUSES” sections of this manual for more information.
4. **GATE.** This TTL-level (0 and +5V) logic input can be used to gate the triggering of the instrument. This input can be either active high or active low, depending on the front panel settings or programming commands. (The instrument triggers normally when this input is unconnected). When set to active high mode, this input is pulled-down to ground by a 1 k Ω resistor. When set to active low mode, this input is pulled-up to +5V by a 1 k Ω resistor.
5. **TRIG.** This TTL-level (0 and +5V) logic input can be used to trigger the instrument, if the instrument is set to triggering externally. The instrument triggers on the rising edge of this input. The input impedance of this input is 1 k Ω . (Depending on the length of cable attached to this input, and the source driving it, it may be desirable to add a coaxial 50 Ohm terminator to this input to provide a proper transmission line termination. The Pasternack (www.pasternack.com) PE6008-50 BNC feed-thru 50

Ohm terminator is suggested for this purpose.)

6. GPIB Connector. A standard GPIB cable can be attached to this connector to allow the instrument to be computer-controlled. See the “Programming Manual for -B Instruments” for more details on GPIB control.
7. RS-232 Connector. A standard serial cable with a 25-pin male connector can be attached to this connector to allow the instrument to be computer-controlled. A user name (“admin”) and a password (“default”, as shipped from the factory) are required when logging into a serial terminal session. The internal controller attempts to auto-sense the parity setting. It may be necessary to send a few return characters before attempting a login in order to provide enough data to allow this auto-sensing to work. (A standard Linux “agetty” process is used to implement serial control internally.) See the “Programming Manual for -B Instruments” for more details on RS-232 control.
8. PULSE OUT CONNECTOR. This BNC connector provides the pulse output signal to the test jig. This output should be connected to the corresponding input on the test jig using one of the the supplied coaxial cables (60 cm or 5 m).

 Caution: Voltages as high as 240V may be present on the center conductor of this output connector. Avoid touching this conductor. Connect to this connector using standard coaxial cable, to ensure that the center conductor is not exposed.

9. CONTROL Connector. This DB-9 female connector should be connected to the corresponding connector on the test jig using the supplied DB-9 cable. This cable contains the safety interlock signals that ensure that the test jig lid is closed. The pinout is as follows:

Pin 1 - To test jig switch 1.

Pin 2 - To test jig switch 2.

Pin 5 - Ground.

Pin 6 - To test jig switch 1.

Pin 7 - To test jig switch 2.

Pin 9 - Safety sensor power supply (+15V through 680 Ohms).

When the test jig lid is safely closed, Pin 1 is shorted to Pin 6, and Pin 2 is shorted to Pin 7.

10. Network Connector. (Optional feature. Present on -VXI units only.) This Ethernet connector allows the instrument to be remotely controlled using the VXI-11.3, ssh (secure shell), telnet, and http (web) protocols. See the “Programming Manual for -B Instruments” for more details.

TIMING CONTROL

BASIC TIMING CONTROL

This instrument can be triggered by its own internal clock or by an external TTL trigger signal. In either case, two output channels respond to the trigger: PULSE and SYNC.

The PULSE output is a bipolar signal that may either drive a 50 Ohm load, or the test jig described later. The positive and negative amplitudes are adjustable. The pulse widths are variable over a 2-20 us range.

The SYNC pulse is a fixed-width TTL-level reference pulse used to trigger oscilloscopes or other measurement systems. When the delay is set to a positive value the SYNC pulse precedes the PULSE output. When the delay is set to a negative value the SYNC pulse follows the PULSE output.

These pulses are illustrated below, assuming internal triggering and a positive delay:

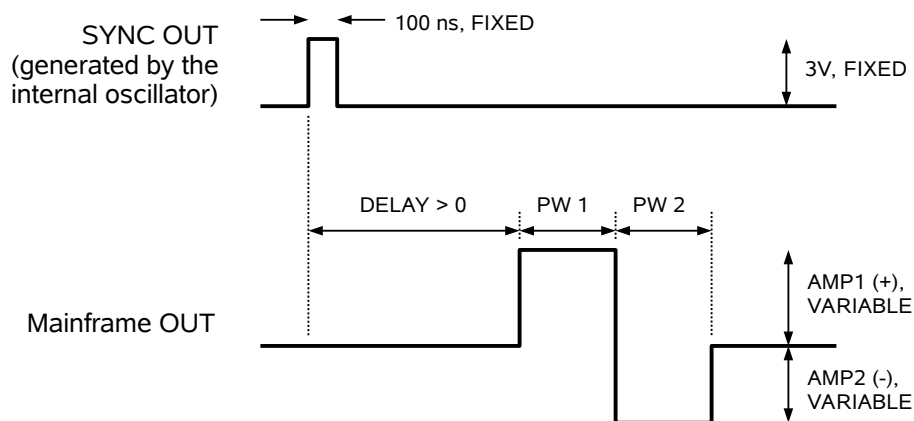


Figure A

If the delay is negative, the order of the SYNC and PULSE outputs is reversed:

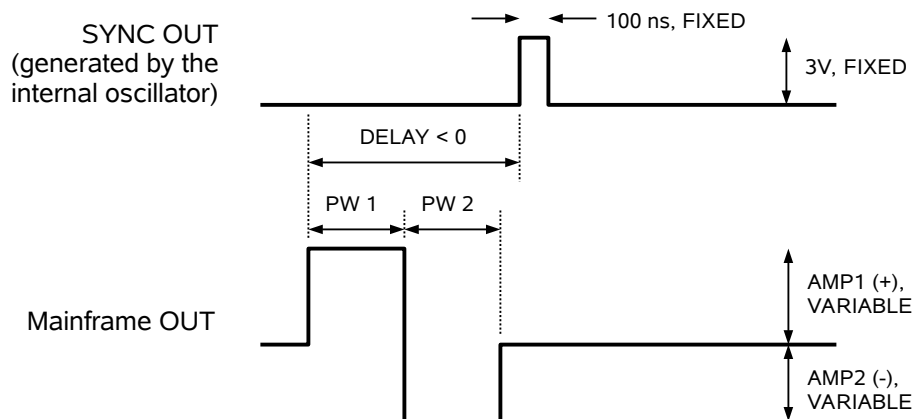


Figure B

The next figure illustrates the relationship between the signal when an external TTL-level trigger is used:

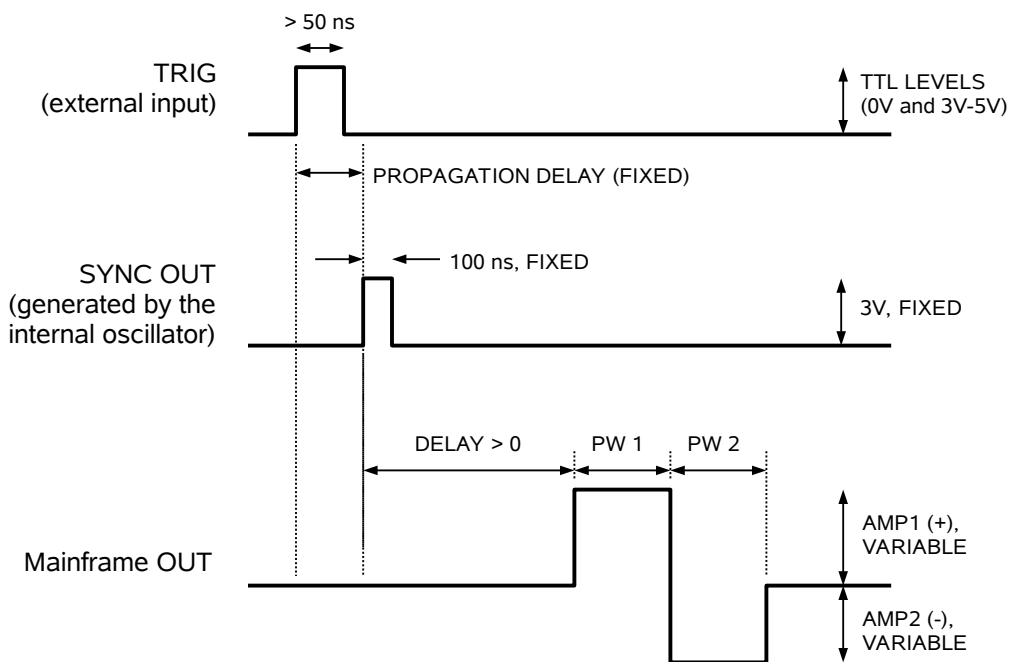


Figure C

As before, if the delay is negative, the order of the SYNC and PULSE outputs is reversed.

The delay and frequency (when in the internal mode) of the PULSE output can be varied with front panel controls or via the GPIB or RS-232 computer interfaces.

TRIGGER MODES

This instrument has four trigger modes:

- Internal Trigger: the instrument controls the trigger frequency, and generates the clock internally.
- External Trigger: the instrument is triggered by an external TTL-level clock on the back-panel TRIG connector.
- Manual Trigger: the instrument is triggered by the front-panel “SINGLE PULSE” pushbutton.
- Hold Trigger: the instrument is set to not trigger at all.

These modes can be selected using the front panel trigger menu, or by using the appropriate programming commands. (See the “Programming Manual for -B Instruments” for more details.)

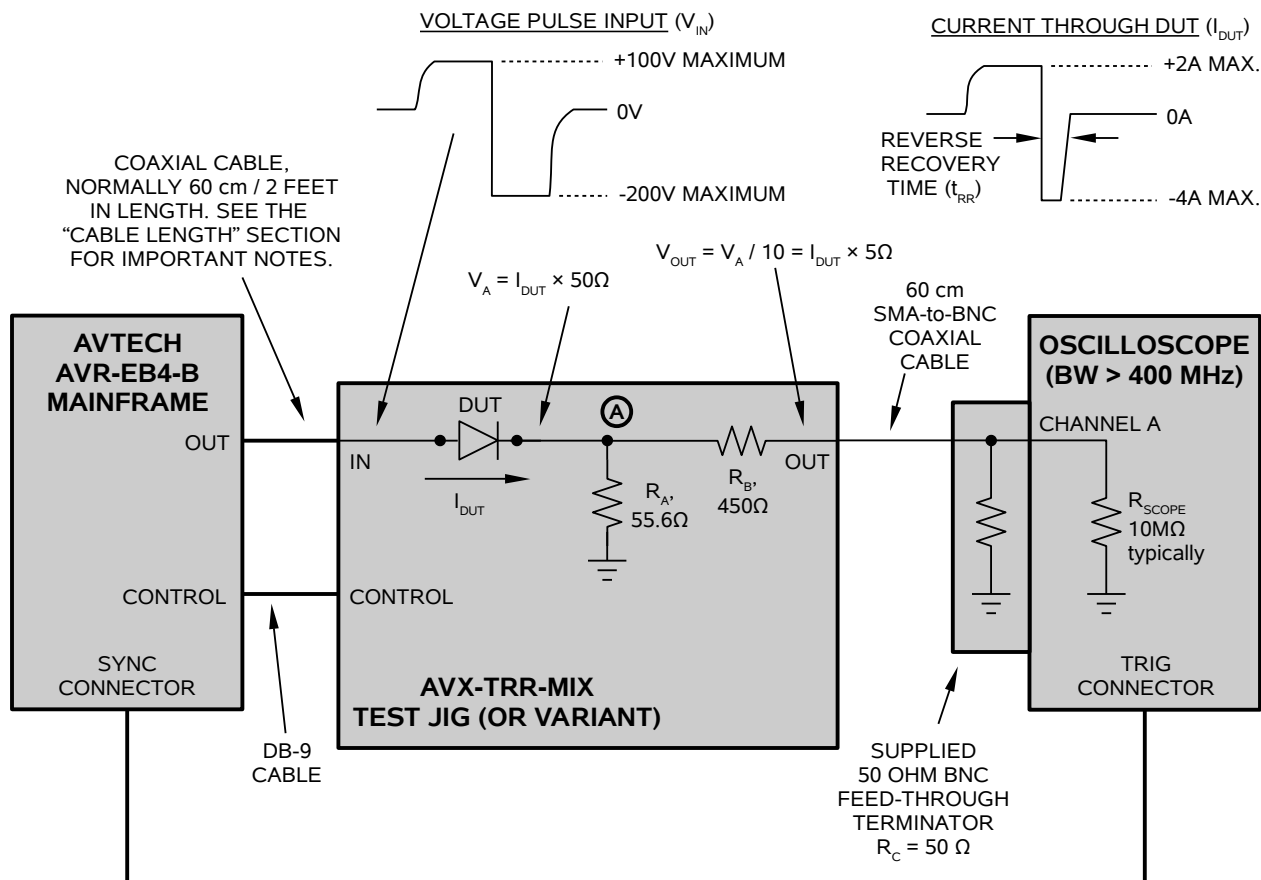
GATING MODES

Triggering can be suppressed by a TTL-level signal on the rear-panel GATE connector. The instrument can be set to stop triggering when this input high or low, using the front-panel gate menu or the appropriate programming commands. When gated, the output will complete the full pulse width if the output is high, and then stop triggering. Pulses are not truncated.

BASIC AMPLITUDE CONTROL

The basic test arrangement for the AVR-EB4-B is shown in the figure below. The PULSE output on the instrument mainframe is connected to the PULSE input on the test jig (model AVX-TRR-MIX, or a customized variant) using the supplied coaxial cable, and the control cable is connected using the supplied DB-9 cable.

⚠ Normally, the 60 cm / 2 foot-long coaxial cable should be used, except when reflections are observed on the output waveform.



⚠ A 50 Ohm resistance (R_C in the diagram above) must be connected to ground on the output. This can be a discrete resistor, a feed-through terminator, or the input impedance of an oscilloscope. If a high-speed sampling oscilloscope is used, the input should be protected by adding attenuator on the input. In the diagram above, the supplied 50 Ohm feed-through terminator is used to provide the required 50 Ohm resistance.

The total effective resistance of resistors R_A , R_B , and R_C in the diagram above is 50 Ohms. Thus, the voltage at point "A" is simply given by:

$$V_A = I_{DUT} \times 50\Omega$$

where I_{DUT} is the current through the device under test. A 450 Ohm resistance (R_B) is present in series with the measurement output. When a 50 Ohm resistance (R_C) is installed on the output (by the user), the output voltage will be one-tenth of V_A due to the resistor-divider effect. That is:

$$V_{OUT} = V_A / 10 = I_{DUT} \times 5\Omega$$

This is the key equation for relating the observed voltage waveform to the DUT current.

SETTING THE AMPLITUDE LEVELS

The amplitude of the positive and negative portions of the PULSE waveform may be set from the front panel of the instrument, or by computer command. These settings are expressed in terms of the voltage present on the test jig input.

The positive voltage ("AMP1" on the front panel display) is related to the forward diode current by:

$$I_{FORWARD} \approx (AMP1 - V_F) / (50\Omega + R_{DIODE-FORWARD})$$

where V_F is the forward voltage drop of the diode (typically 0.7V for the classic silicon PN junction diode, and usually somewhat lower for a Schottky diode), and $R_{DIODE-FORWARD}$ is the effective resistance of the diode under forward bias.

The negative voltage ("AMP2" on the front panel display) is related to the reverse diode current by:

$$I_{REVERSE} \approx AMP2 / (50\Omega + R_{DIODE-REVERSE}).$$

Where $R_{DIODE-REVERSE}$ is the effective resistance of the diode under reverse bias.

It is important to note that $R_{DIODE-FORWARD}$ and $R_{DIODE-REVERSE}$ are not the same, and that they may change during the transient. Furthermore, depending on the design of the diode under test, it is possible that $R_{DIODE-REVERSE}$ may be so high that it is impossible to achieve the full 4 Amps of reverse current. (The ideal diode would of course have $R_{DIODE-REVERSE} = \infty$). The reverse voltage can actually be increased to -240V (rather than the nominal maximum of -200V) to increase the likelihood of obtaining the full 4 Amps of reverse current.

Most test procedures for measuring recovery time will use a particular ratio of forward to reverse currents - for example, $I_{REVERSE} / I_{FORWARD} = 2$.

Some Schottky diodes have negligible amounts of stored charge resulting from the forward bias, compared to non-Schottky devices. For these Schottky diodes, the reverse transient will be governed by the capacitance of the device, and the reverse transient may be largely unaffected by the amplitude of the forward transient. (In other words, the $I_{\text{REVERSE}} / I_{\text{FORWARD}}$ ratio is irrelevant). The capacitance may be so small that it becomes impossible to obtain the full -4 Amps of reverse current.

Normally, the forward and reverse amplitudes should be set near the maximum values (+100V, -200V). Performance may degrade if the amplitudes are set lower than 10% of the maximum values.

AMPLITUDE ACCURACY

Due to the variations in V_F and $R_{\text{DIODE-FORWARD}}$ and $R_{\text{DIODE-REVERSE}}$ as a function of operating conditions, the AMP1 and AMP2 settings *should not be relied upon for any degree of accuracy*. Instead the voltage at the OUT terminal on the test jig should be monitored with a calibrated oscilloscope. As mentioned above, $I_{\text{DUT}} = V / 5\Omega$.

It is particularly important that the oscilloscope's parasitic DC offset be properly nulled. A non-zero offset can introduce significant errors in calculating $I_{\text{REVERSE}} / I_{\text{FORWARD}}$, leading to errors in the measured recovery time.

R_A and R_B can be measured directly on the test jig (with the test jig disconnected) to determine calibrated relationships, if desired. R_C is provided by the user, and can be calibrated as required.

INCORRECT ORIENTATION


The instrument and the DUT will not be damaged if the diode is installed with the incorrect orientation (i.e., with the anode and cathode reversed). However, incorrect waveforms will be generated,

CABLE LENGTHS


The test jig is connected to the mainframe using two cables:

- 1) A 2-meter-long DB-9 control cable
- 2) A coaxial cable.

The length of the coaxial cable affects the measured waveform slightly. The cable length should be chosen based on the type of diode that will be tested.

 Normally, the 60 cm / 2 foot-long coaxial cable should be used, except when reflections are observed on the output waveform.

However, diodes with extremely short recovery times (< 10 ns), like ultra-fast Schottky diodes, or diodes with “step recovery” or “hard switching” characteristics, may generate noticeable reflections after the end of the reverse transient. If these reflections overlap with the transient itself, a longer cable should be used. This will increase the period of the reflections, placing them well after the transient where they may be ignored. A 5-meter-long cable is supplied for this purpose.


 For “soft-switching” diodes, the shortest possible cable length should be used. The 60-cm-long coaxial cable should be used for these applications. When a “soft switching” diode nears the end of its reverse transient, the diode turns off more gradually. This does not produce reflections, but the impedance mismatch that slowly develops means that the attached cable acts as a capacitance. This tends to extend the waveform slightly, leading to a small ($\sim 10\%$) over-estimation of the reverse recovery time.


In summary, the shortest possible coaxial cabling should be used, except when “hard switching” causes noticeable reflections. In that case, use longer cable lengths.

Example waveforms are included in the “TYPICAL RESULTS” section.

ACCESSIBLE VOLTAGES

The mainframe provides pulsed voltages of up to 240V to the test jig. For this reason, the output is automatically disabled when the test jig lid is open. The lid must be closed to obtain measurements.

 Shielded cabling should be used for all connections to the “IN” and “OUT” terminals on the test jig, and the “OUT” connector on the mainframe.

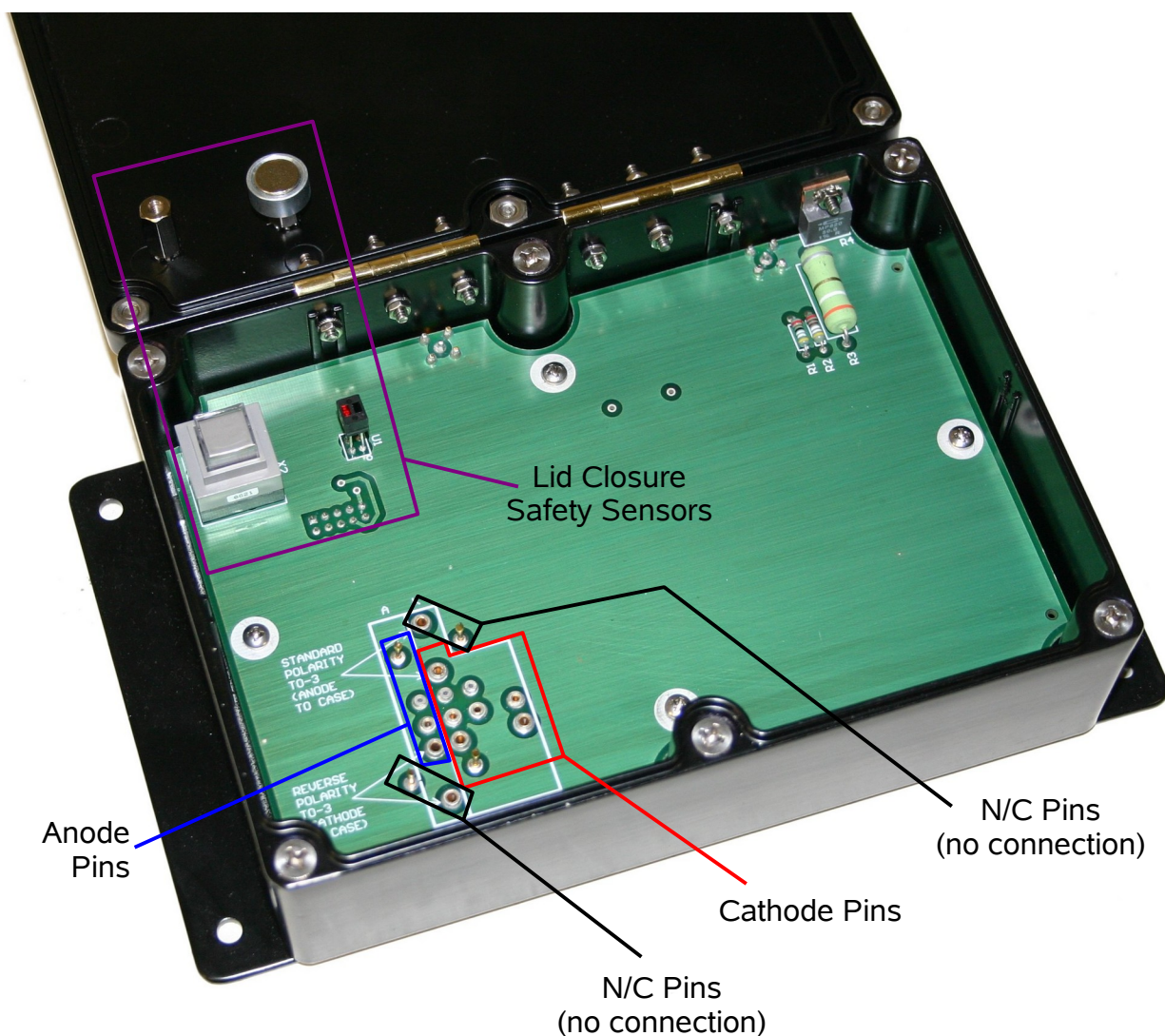
 When used properly (with $R_C = 50$ Ohms), the maximum voltage on the OUT terminal will be 24V, approximately. However, if R_C is not connected, the maximum voltage will at the OUT terminal may be as high as 240V. Avoid feeding this output directly into an oscilloscope. Always use a probe, attenuator, or feed-through terminator!

STANDARD TEST JIG MECHANICAL ASPECTS

One AVX-TRR-MIX test jig is normally supplied with the mainframe, unless the customer has requested a different or additional test jigs.

AVX-TRR-MIX TEST JIG

The AVX-TRR-MIX test jig accepts a range of through-hole and axial devices, using pin sockets and spring-loaded pins. It is intended for use with diodes in DO-41, TO-220, DO-204AR, TO-3 or similar packages. A photo of the arrangement is shown below:



The instrument and the DUT will not be damaged if the diode is installed with the incorrect orientation (i.e., with the anode and cathode reversed). However, incorrect waveforms will be generated.

The procedure for inserting most axial and TO-220 packages is straightforward. Simply insert the DUT between one of the Anode pin sockets (in the blue area above) and one of the Cathode sockets (in the red area above). Select the sockets with the most appropriate hole size, and try to minimize all lead lengths, to minimize parasitic inductance.

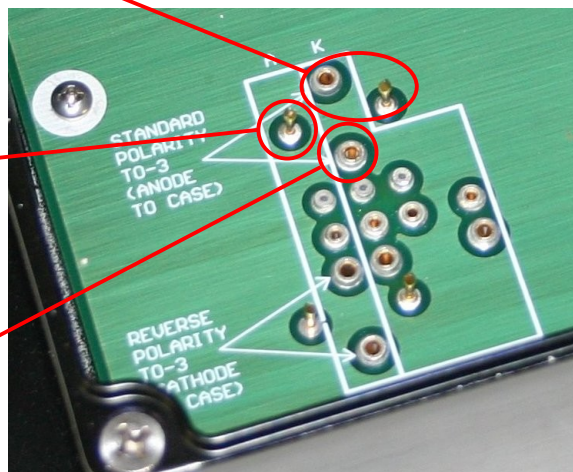
This jig will also accommodate a number of TO-3 configurations, outlined below. If the case is connected to the anode, and the pin(s) are used for the cathode, the arrangement shown below must be used:

This socket and spring pin provide mechanical support only. They are not electrically active.

This spring pin must contact the underside of the case. It provides the anode connection.

The cathode pin of interest must be inserted into this socket. For dual-diode devices, rotate the TO-3 package so that the desired diode cathode is inserted here.

**For TO-3 packages
with Case = Anode**

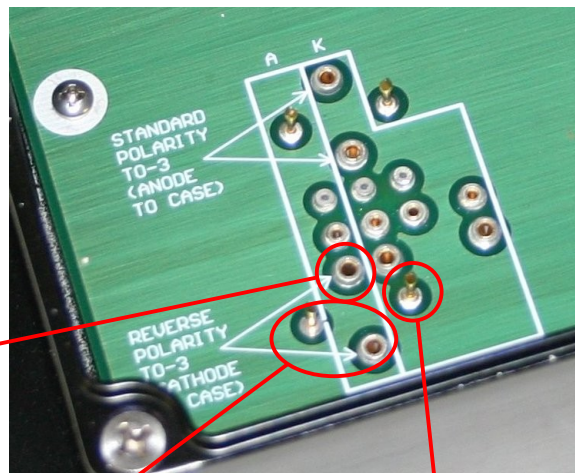


If the case is connected to the cathode, and the pin(s) are used for the anode, the arrangement shown below must be used:

**For TO-3 packages
with Case = Cathode**

The anode pin of interest must be inserted into this socket. For dual-diode devices, rotate the TO-3 package so that the desired diode anode is inserted here.

This socket and spring pin provide mechanical support only. They are not electrically active.



This spring pin must contact the underside of the case. It provides the cathode connection.

The IN, OUT, and CONTROL connectors are on the rear of the jig, below the hinges:

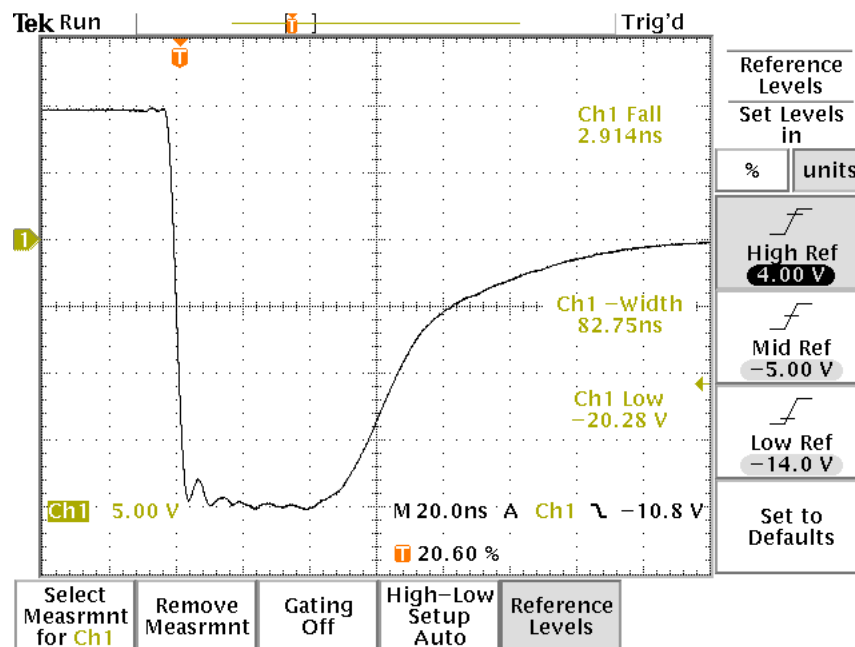


TYPICAL RESULTS

Obtaining meaningful results with the AVR-EB4-B requires care, experience, and an understanding of diode transient behavior and the impact of inductive and capacitive parasitics. To assist the user, typical results for commercially available diodes are provided below. The user should be able to reliably duplicate these results.

1N4937 RESULTS

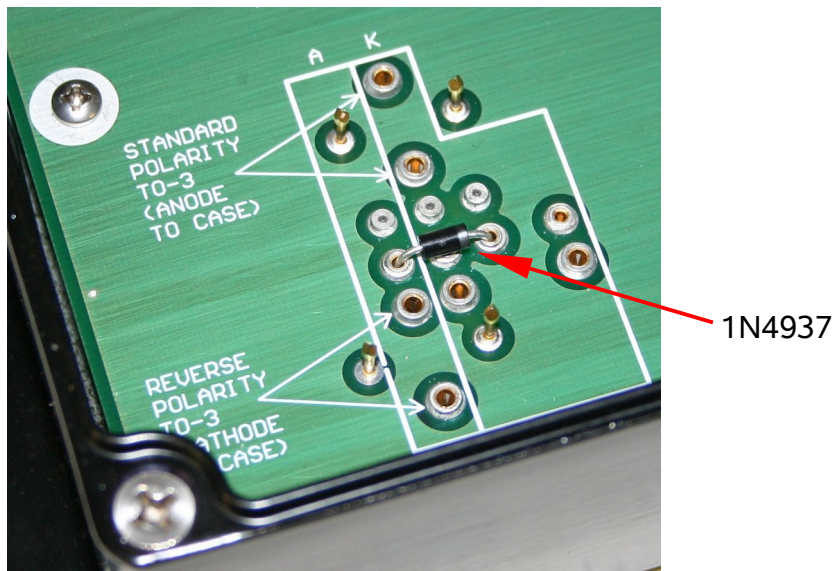
The On Semiconductor 1N4937 is a 1A, 600V DO-41 fast-recovery rectifier. With the amplitudes set to +100V and -200V, and with the mainframe connected to the test jig using a 60 cm coaxial cable, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:



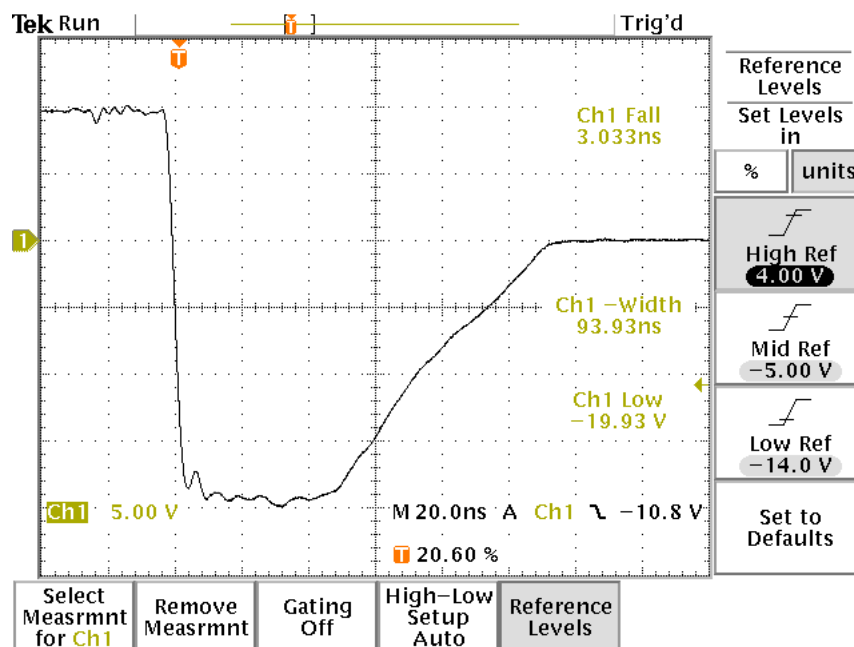
5 V/div (= 1 A/div), 20 ns/div.
20%-80% switching time shown.
S/N 11713. 60 cm cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 82.75 ns under these conditions (measured at the 25% reverse current point).

For this test, the 1N4937 was installed as shown below:



This transient shows a “soft-switching” recovery, and no reflections are observed at the end of the transient, so the 60 cm coaxial cable was used. If the 5 m cable is used, the measured recovery time will be too high, as shown below:

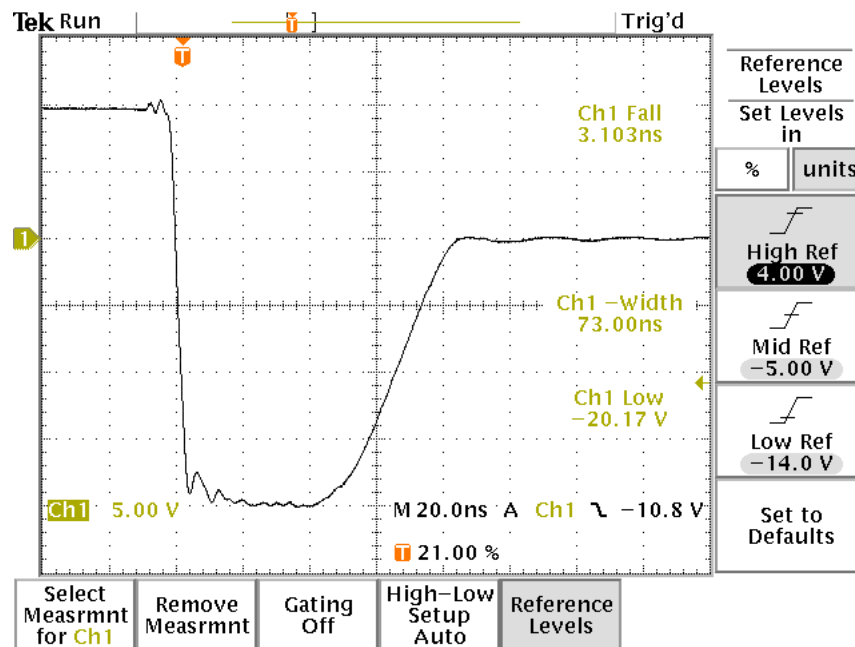


5 V/div (= 1 A/div), 20 ns/div.
20%-80% switching time shown.
S/N 11713. 5m cable used.

The use of the incorrect cable boost the observed recovery time from ~ 83ns to ~ 94 ns.

J5418 RESULTS

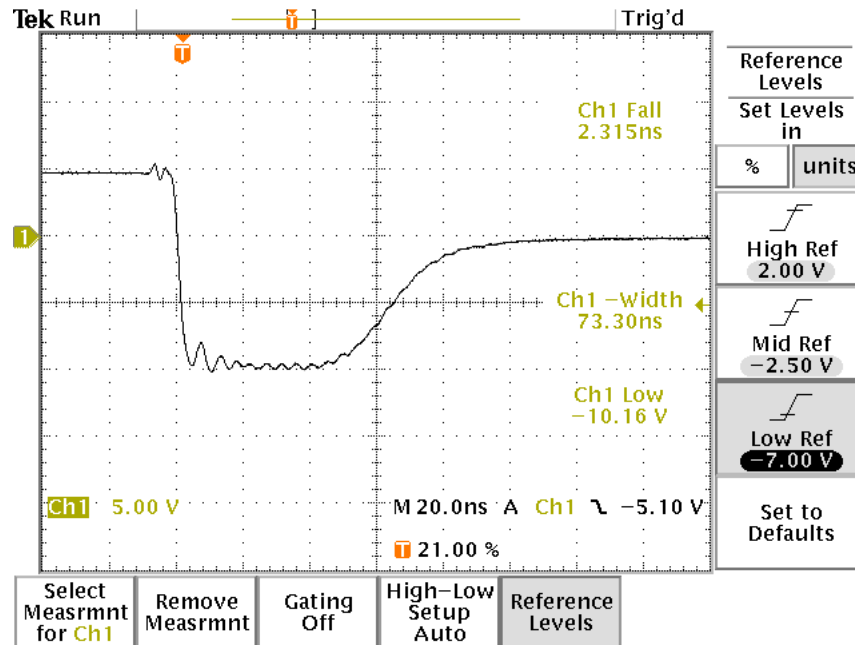
The Microsemi J5418 was tested with amplitudes set to +100V and -200V, and with the mainframe connected to the test jig using a 60 cm coaxial cable. The following reverse recovery waveform was obtained at the test jig "OUT" terminal:



5 V/div (= 1 A/div), 20 ns/div.
 20%-80% switching time shown.
 S/N 11713. 60 cm cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 73 ns under these conditions (measured at the 25% reverse current point).

This diode was also tested under +1A / -2A conditions, which produced a nearly identical figure for t_{RR} :

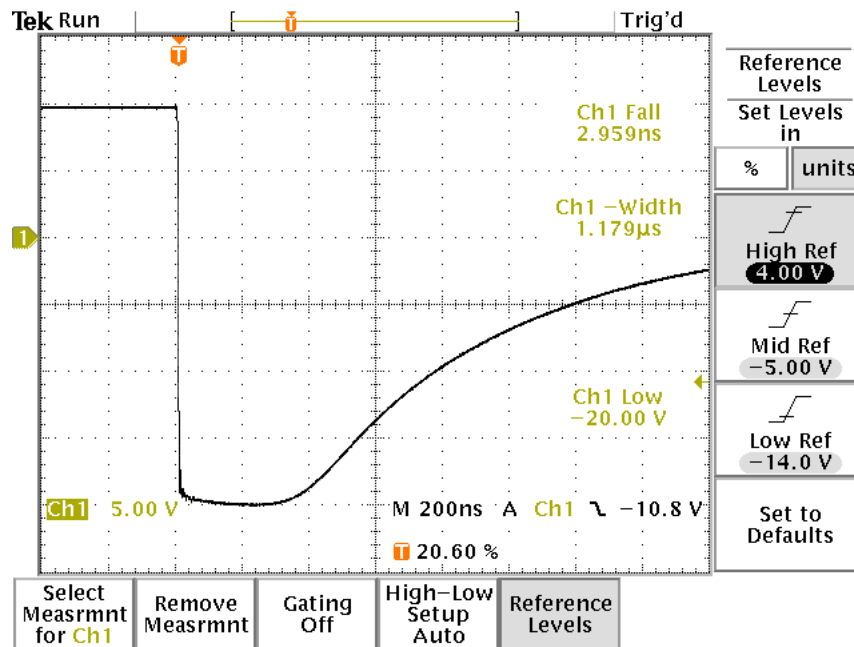


5 V/div (= 1 A/div), 20 ns/div.
 20%-80% switching time shown.
 S/N 11713. 60 cm cable used.

In this case, 73.3 ns was measured for +1A/-2A, versus 73.0 ns for +2A/-4A.

1N4004 RESULTS

The generic 1N4004 is a very slow 1A, 400V DO-41 fast-recovery rectifier. With the amplitudes set to +100V and -200V, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:

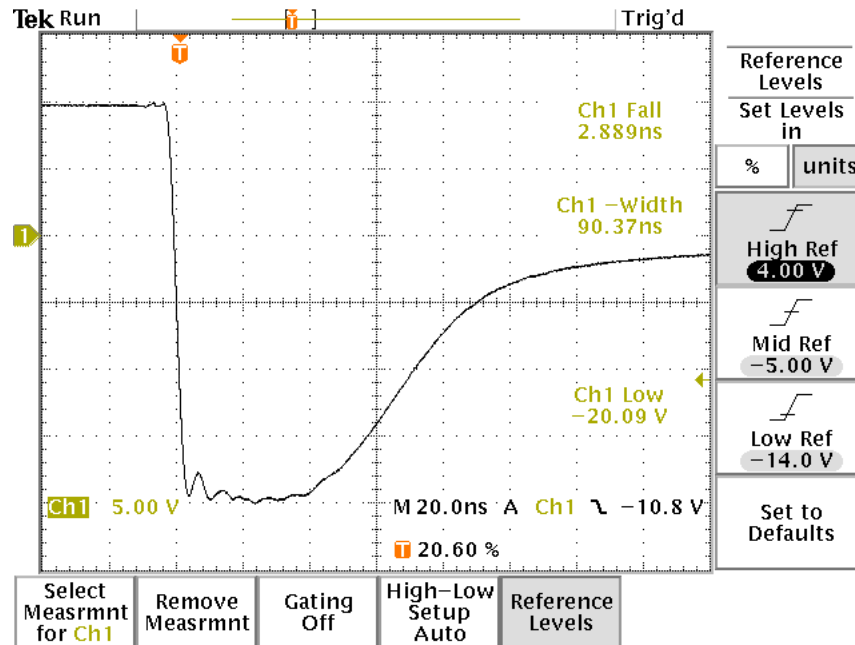


5 V/div (= 1 A/div), 200 ns/div.
 20%-80% switching time shown.
 S/N 11713. 60 cm cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient duration exceeds 1 μ s under these conditions.

MUR8100E RESULTS

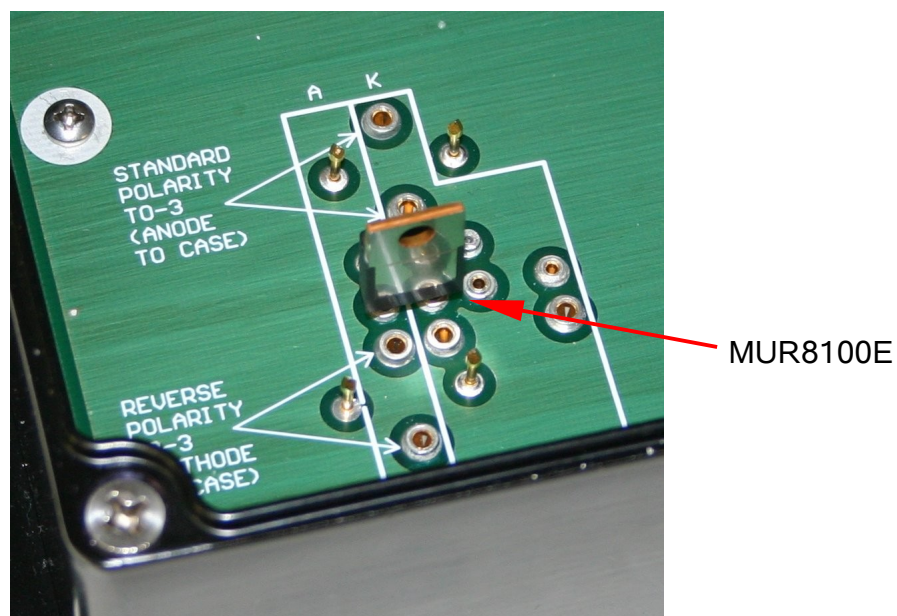
The On Semiconductor MUR8100E is a 8A, 1000V TO-220 ultrafast rectifier. With the amplitudes set to +100V and -200V, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:



5 V/div (= 1 A/div), 20 ns/div.
 20%-80% switching time shown.
 S/N 11713. 60 cm cable used.

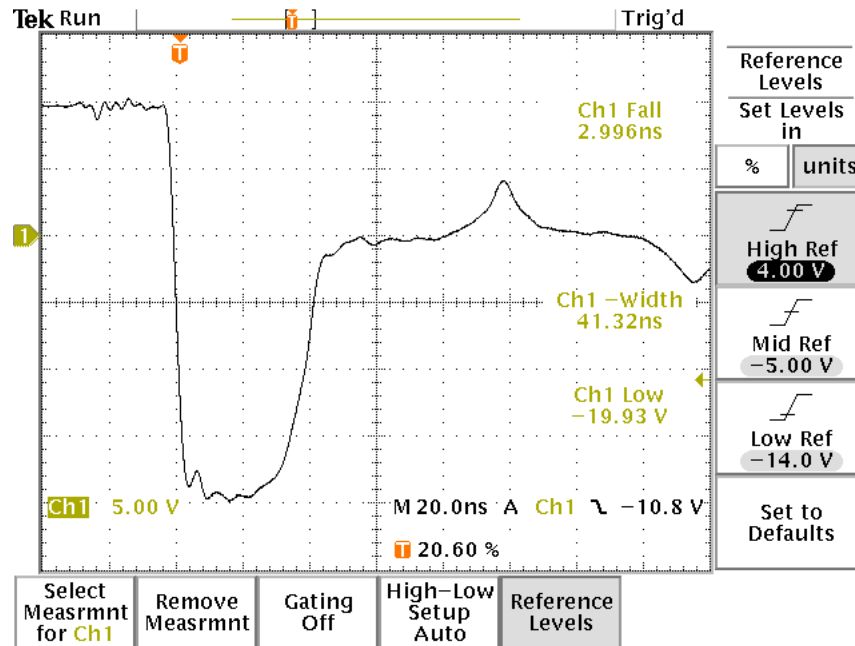
The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 90 ns under these conditions.

For this test, the MUR8100E was installed as shown below:



RUS460 RESULTS

The EDI RUS460 is a 5A, 600V DO-204AR ultrafast rectifier. With the amplitudes set to +100V and -200V, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:

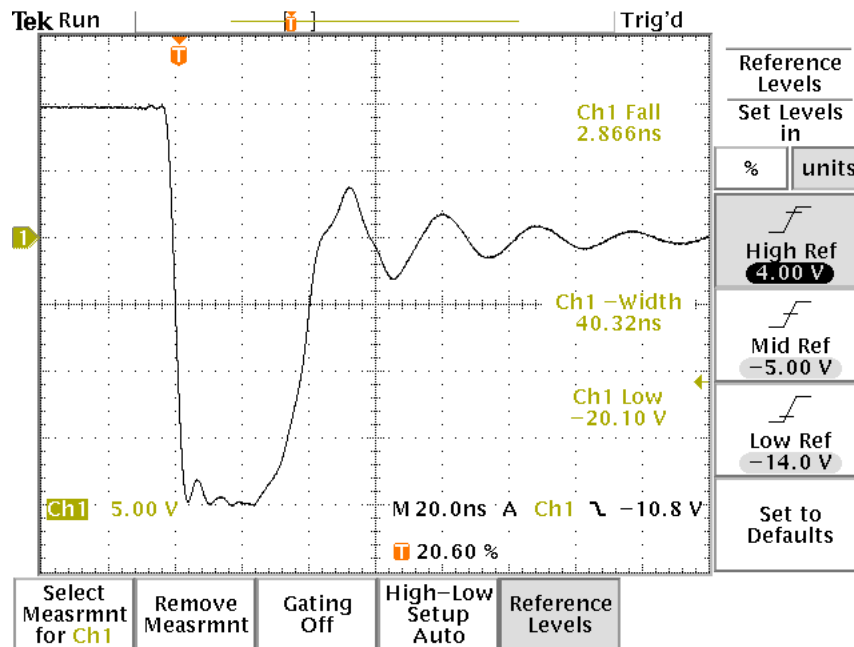


5 V/div (= 1 A/div), 20 ns/div.
 20%-80% switching time shown.
 S/N 11713. 5m cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 40 ns under these conditions, and then ends rather abruptly. This abrupt termination of the reverse transient is somewhat unusual, and is referred to as a "hard" or "step" transient. Most modern diodes are optimized to provide a "soft" transient, with a more gradual decay of the reverse current from its peak value to zero.

The fast switching time of the hard transient causes transmission line reflections to occur. These reflections repeat in an exponential decay pattern, until they are no longer detectable. The time between reflections is governed by the length of coaxial cabling (normally 5 meters) connecting the mainframe to the output module. These reflections can normally be ignored, since they occur after the end of the "interesting" part of the transient where measurements are made. The coaxial cable can be extended to move the reflection away from the switching transient.

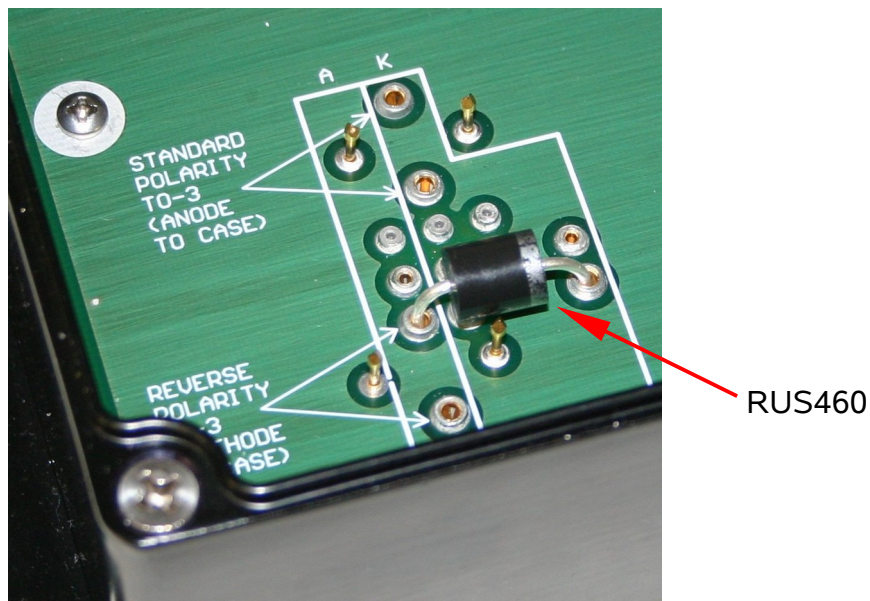
In this test, a 5m coaxial cable was used. If the 60 cm cable were used, the following waveform would be obtained:



5 V/div (= 1 A/div), 20 ns/div.
20%-80% switching time shown.
S/N 11713. 60 cm cable used.

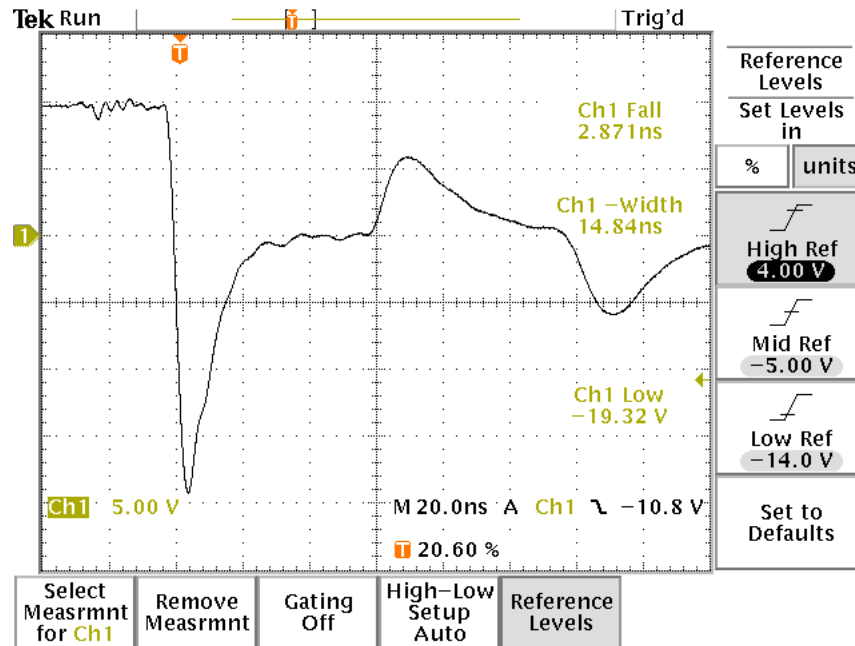
With the 60 cm cable, the measured recovery time is nearly the same as before, but the reflections overlap the transient. In this case, it is best to use the 5m, to clearly separate the two effects (recovery versus reflections).

For this test, the RUS460 was installed as shown below:



CSD10120 RESULTS

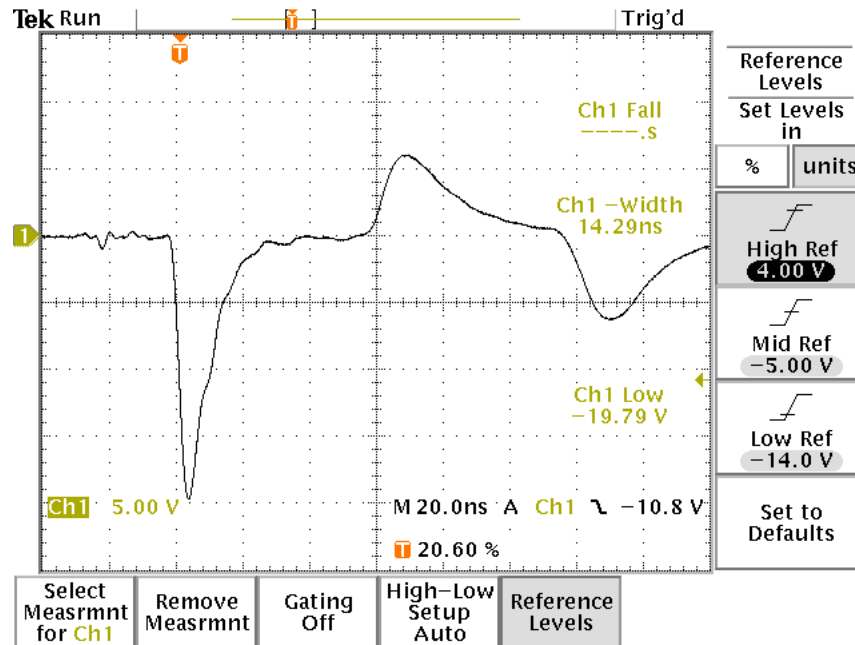
The Cree CSD10120 is a state-of-the-art 1200 Volt, 10 Amp TO-220-packaged Silicon Carbide Schottky diode, promoted as a "Zero Recovery Rectifier". The waveform below shows the results obtained with the CSD10120 diode installed in the AVX-TRR-MIX test jig:



5 V/div (= 1 A/div), 20 ns/div.
20%-80% switching time shown.
S/N 11713. 5m cable used.

The 5 m cable was used, due to the presence of reflections on the output waveform.

Unlike most conventional diodes, the CSD10120 reverse recovery transient is dominated by the capacitance of the device, rather than by minority carrier charge storage. This can be seen by reducing the forward bias current to zero, as shown below:

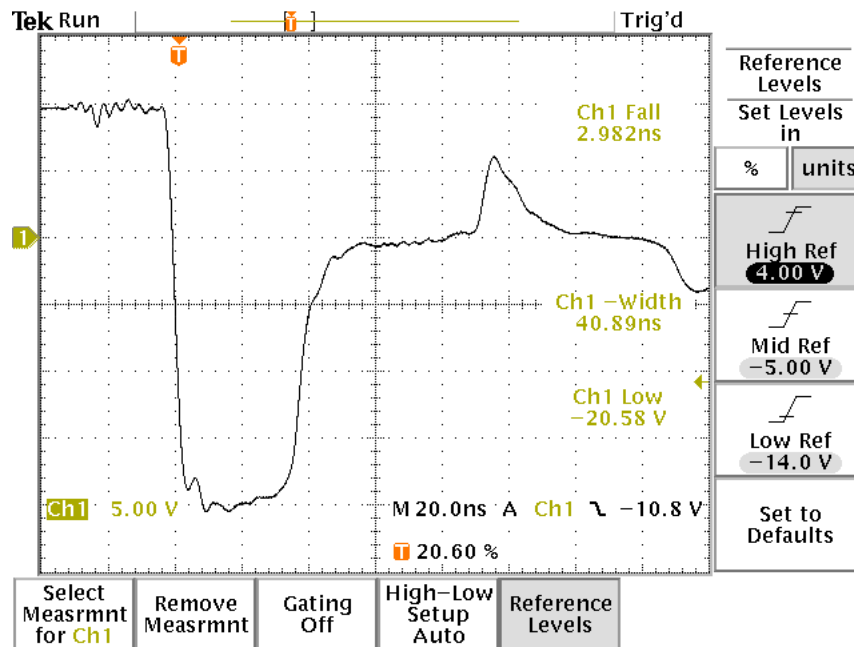


5 V/div (= 1 A/div), 20 ns/div.
20%-80% switching time shown.
S/N 11713. 5m cable used.

The above waveform shows the transition from a forward current of +0A to a reverse current of -4A, approximately. The reverse transient is nearly unchanged, relative to the case when the forward current was +2A! The CSD10120 datasheet says "this is a majority carrier diode, so there is no reverse recovery charge", and the results above largely support this.

UTG8042 RESULTS

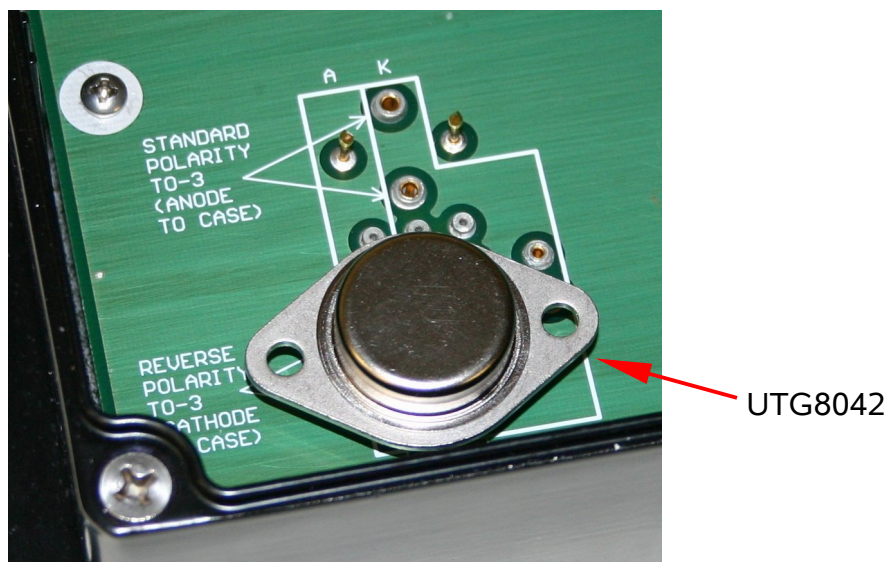
The Microsemi UTG8042 is a dual ultrafast rectifier in a TO-3 package. With the amplitudes set to +100V and -200V, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:



5 V/div (= 1 A/div), 20 ns/div.
 20%-80% switching time shown.
 S/N 11713. 5m cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 41 ns under these conditions, and then ends rather abruptly, causing reflections. The 5m cable was used to ensure that the reflections occur well after the end of the transient.

For this test, the UTG8042 was installed as shown below:



The UTG8042 has two diodes in it. For this test, only the "A" diode was tested.

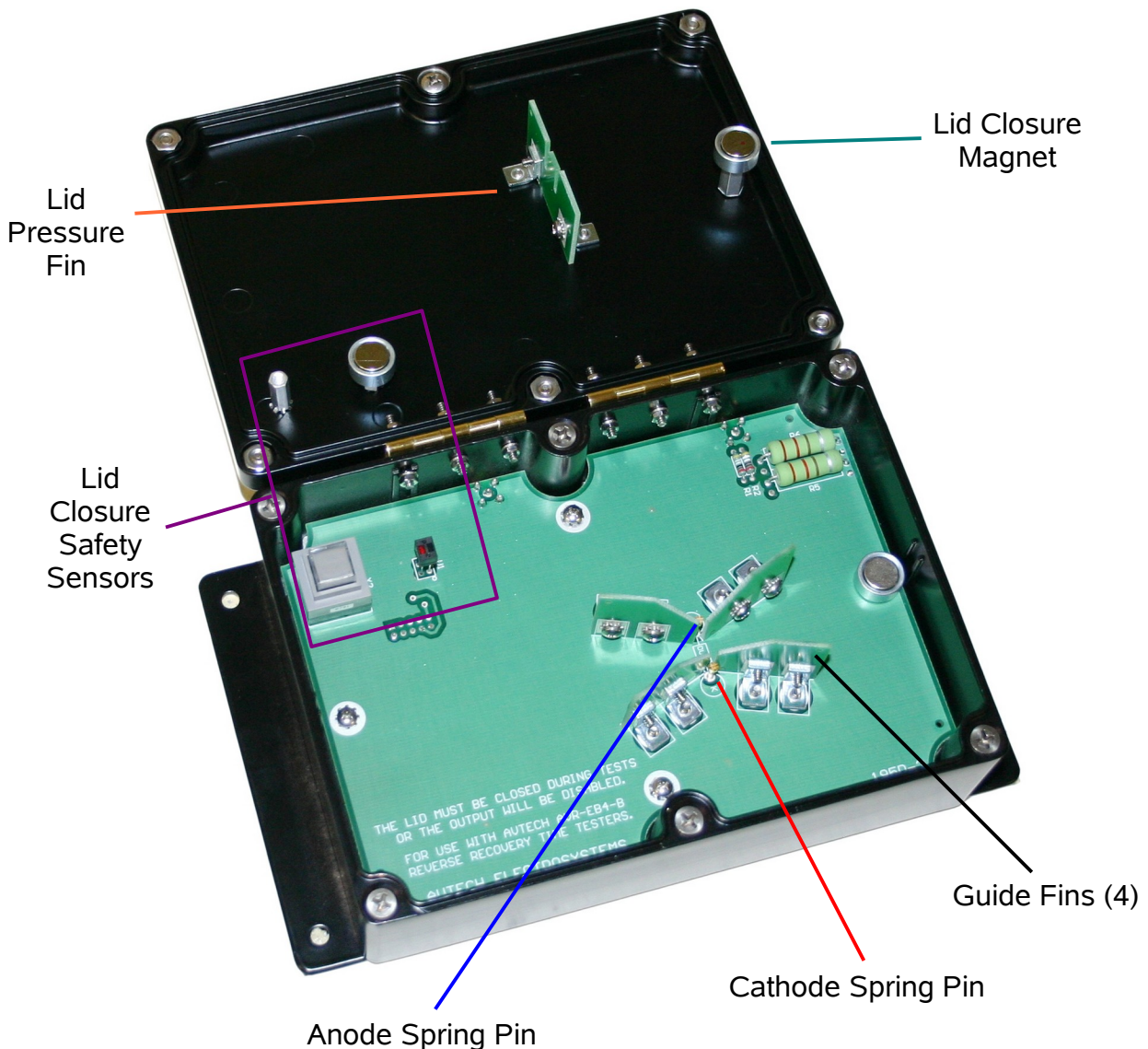
SPECIALIZED TEST JIGS

AVX-TRR-ANB, AXIAL NO-BEND JIG

The AVX-TRR-ANB test jig accepts two types of packages:

- DO-41 (0.205" x 0.107" body, maximum)
- Microsemi Axial Type E (0.185" x 0.135" body, maximum)

The DUT is installed in the test jig by dropping it over the area marked "DUT" on the test jig PCB. Four "fins" guide the DUT into the correct position between two spring-loaded test pins. When the hinged lid is closed, a fifth "fin" attached to the underside of the lid presses the DUT against the spring-loaded pins, to ensure good electrical contact. A DUT is shown in position in the photo below (with the lid open):



The instrument and the DUT will not be damaged if the diode is installed with the incorrect orientation (i.e., with the anode and cathode reversed). However, incorrect waveforms will be generated.

When closed, the lid is held in place by a magnetic latch. To open the lid, simply pull upwards on the handle at the front of the lid.

Over time, the “lid pressure fin” may become worn down, resulting in poor DUT contact with the spring pins. Four replacement fins are included with each AVX-TRR-ANB, for this reason.

AVX-TRR-MELF, MELF JIG

The AVX-TRR-MELF accepts MELF (Metal Electrode Leadless Face) type SMT packages. (Certain customized variants, including the AVX-TRR-SCHA and AVX-TRR-MSB-MELF test jigs, accept the MELF package as well.)

These test jigs use spring-loaded probe pins to contact the device under test. The connection arrangement is the same as for the standard test jig.

The test jig is shown below:



The device under test may be inserted between the spring-loaded pins. These pins are shown below:



The next photo shows a MELF device installed between the two pins:

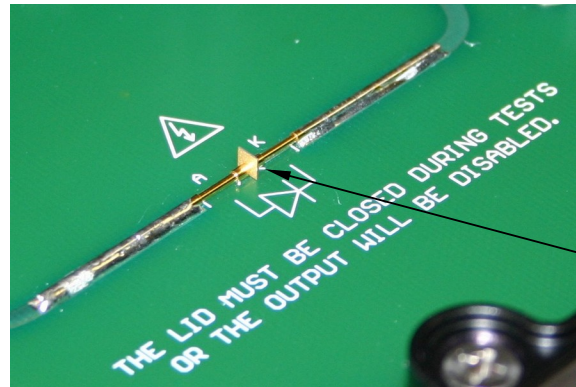


A MELF-packaged
Device Under Test (DUT)

AVX-TRR-MELF, CHIP-LEVEL TESTS

Certain test jigs, including the AVX-TRR-MELF, accept chip-level packages.

These test jigs use spring-loaded flat-headed probe pins to contact the device under test. The connection arrangement is the same as for the standard test jig. An example of this arrangement is shown below:



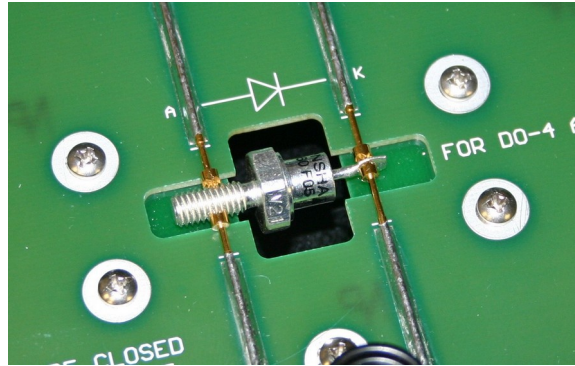
A chip DUT sandwiched between the two flat-headed spring pins.

AVX-TRR-STUD, DO-4 AND DO-5 STUD PACKAGES

Certain test jigs, such as the AVX-TRR-STUD, accept DO-4 AND DO-5 standard and reverse-polarity stud packages. This test jig is shown below:

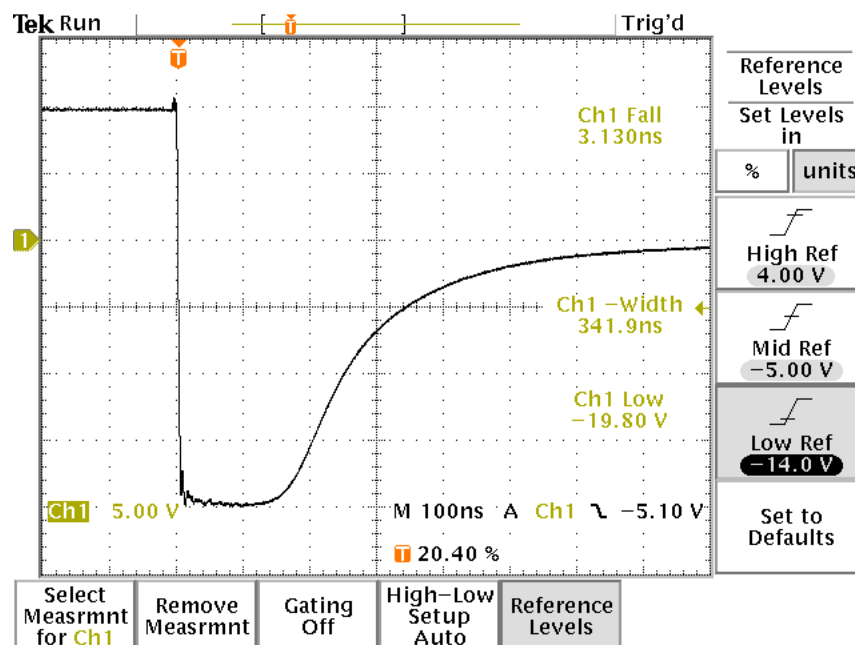


The photo below shows a reverse-polarity DO-4 diode (the Ruttonsha 12FLR60/F05) installed between the four spring-loaded contacts (two for the anode end, and two for the cathode end):



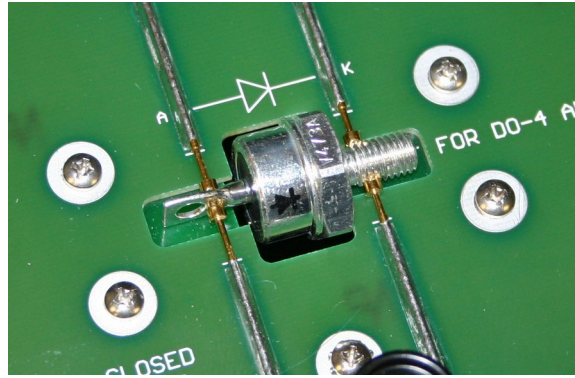
To install the diode, spread apart one pair of spring pins with your fingers or tweezers, and insert one end of the diode. Repeat on the other end.

This diode produced the following results ($t_{RR} = 341.9$ ns):

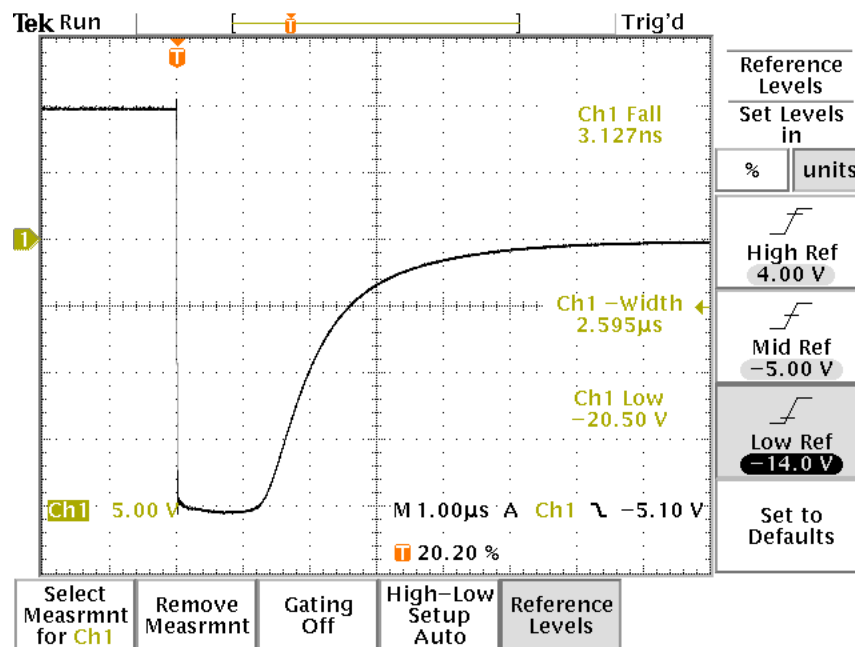


5 V/div (= 1 A/div), 200 ns/div.
20%-80% switching time shown.
S/N 11713. 60 cm cable used.

The photo below shows a reverse-polarity DO-5 diode (the Ruttonsha 40HF80) installed between the four spring-loaded contacts (two for the anode end, and two for the cathode end):



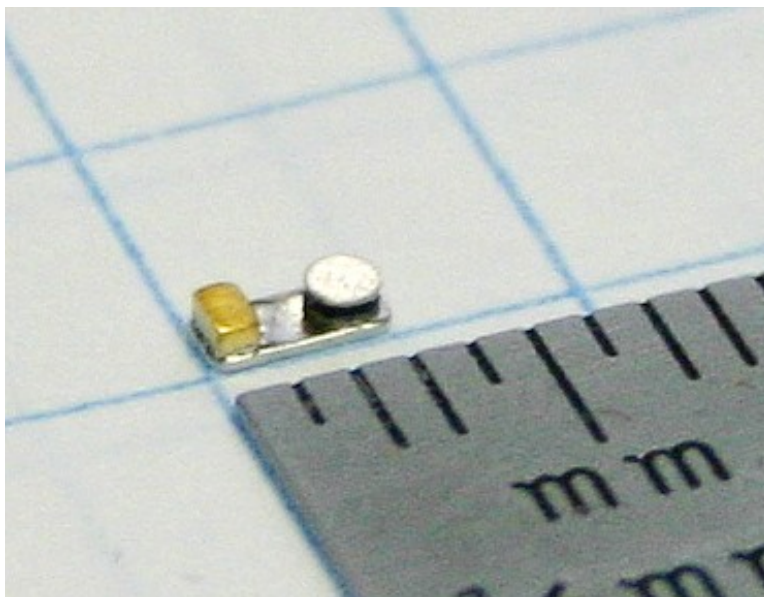
This diode produced the following results ($t_{RR} = 2.595 \mu\text{s}$):



5 V/div (= 1 A/div), 200 ns/div.
20%-80% switching time shown.
S/N 11713. 60 cm cable used.

AVX-TRR-BTA TEST JIG

The AVX-TRR-BTA test jig is designed to accept the unusual package shown below:



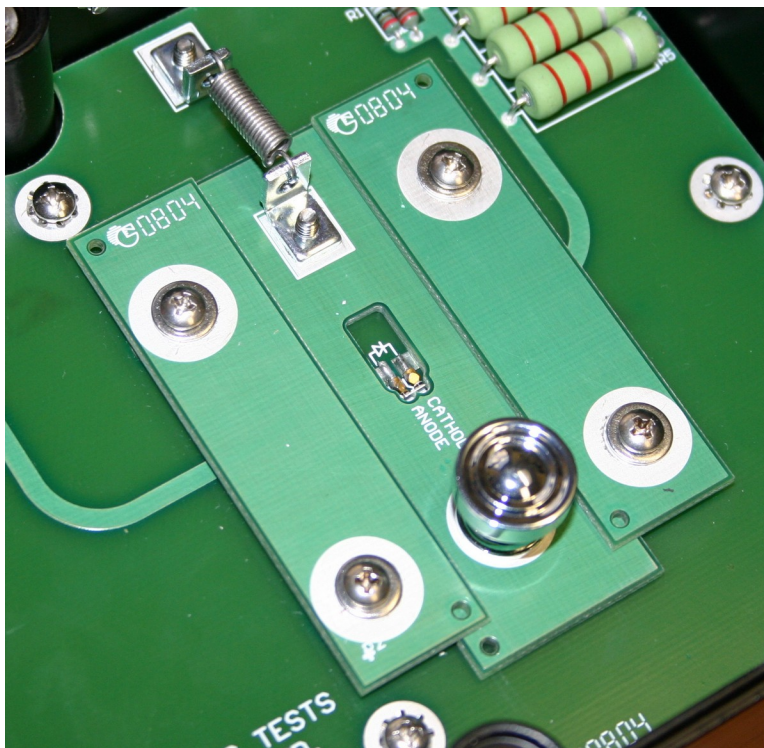
The AVX-TRR-BTA test jig is shown below:



The DUT is installed by pulling back on the chrome knob, as shown below:

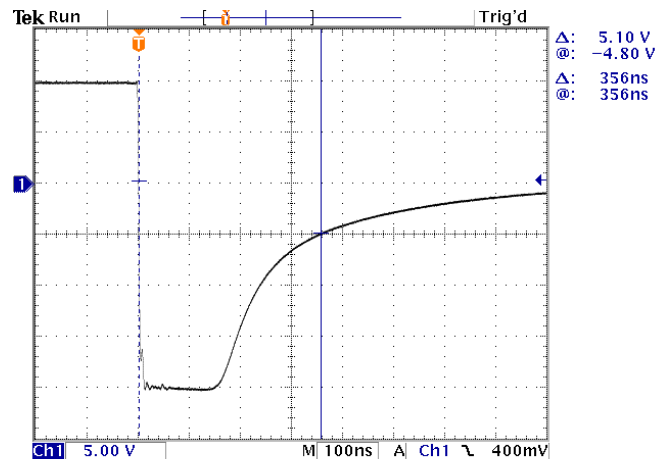


The DUT is then placed on its side in the area immediately in front of the two fixed probe points, as shown in the photo above. Then slowly release the chrome knob, allowing the spring-loaded PCB to push the DUT into position against the two probe points, as shown below. The PCB silk-screening shows the proper device positioning.



The anode pad must contact the left probe point, and the cathode pin must contact the right probe point.

With a user-supplied device (part number unknown) installed in the AVX-TRR-BTA, and with the amplitudes set to generate $I_F = +2A$ and $I_R = -4A$, the following results were obtained:

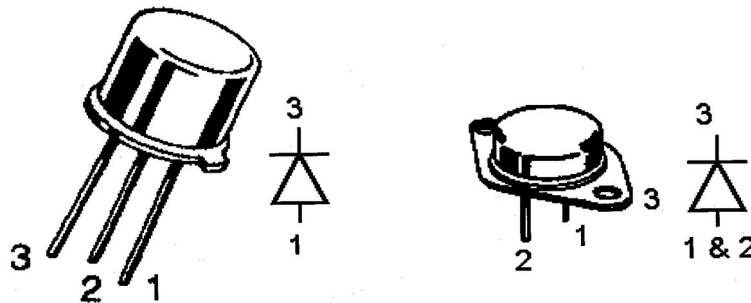


4 Feb 2008
15:17:02

5 V/div (= 1 A/div), 100 ns/div.
 t_{RR} (at 25% of I_R) = 356 ns.
S/N 11910. 60 cm cable used.

AVX-TRR-SDA TEST JIG

The AVX-TRR-SDA is designed to accept TO-3 and TO-5 packages with the pinouts shown below:

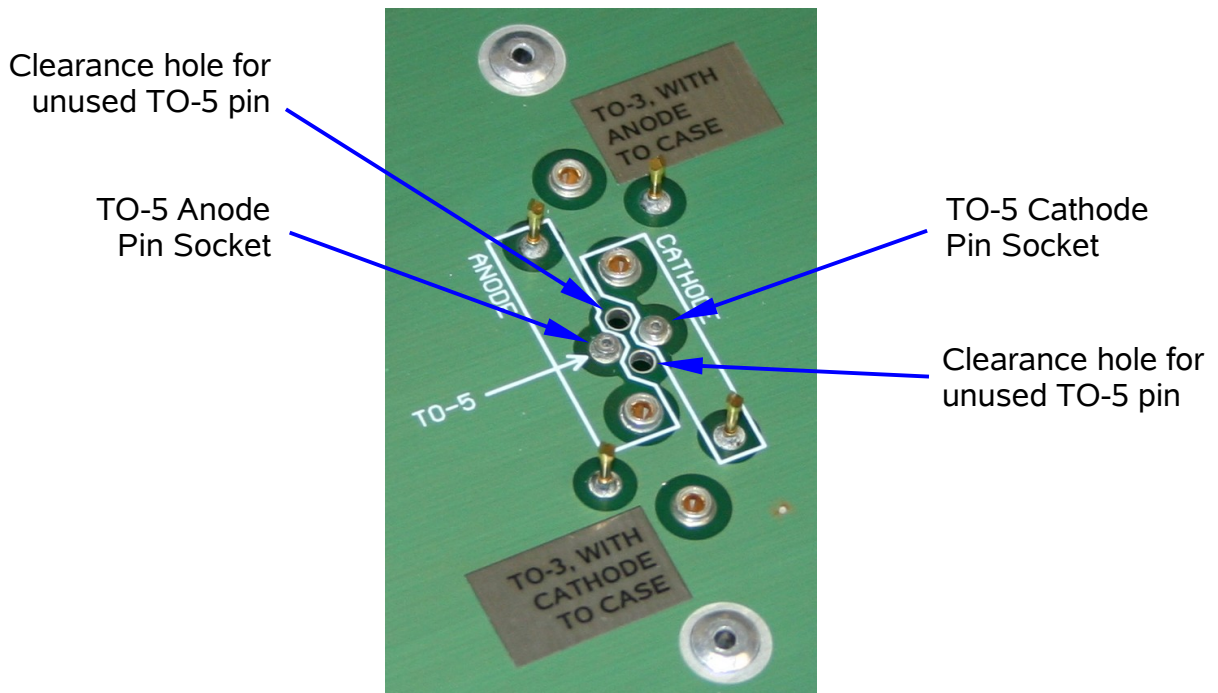


The AVX-TRR-SDA will also accept packages with reverse polarities (with the anode and cathode swapped relative to the above diagrams).

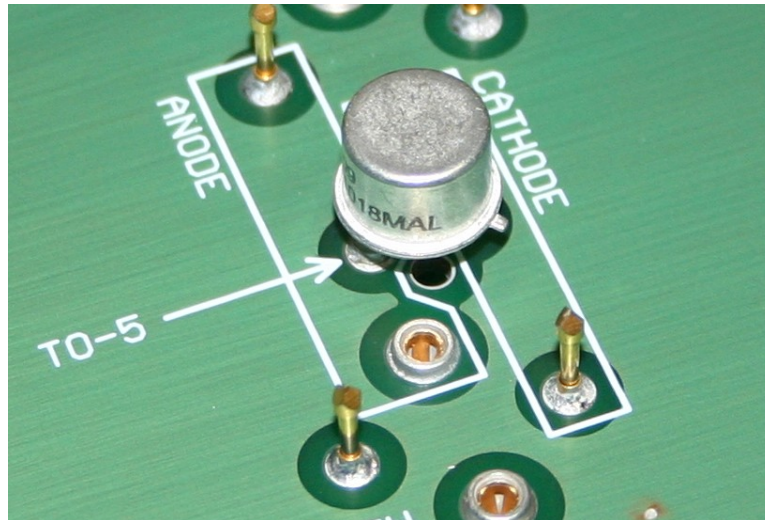
The jig is shown below:



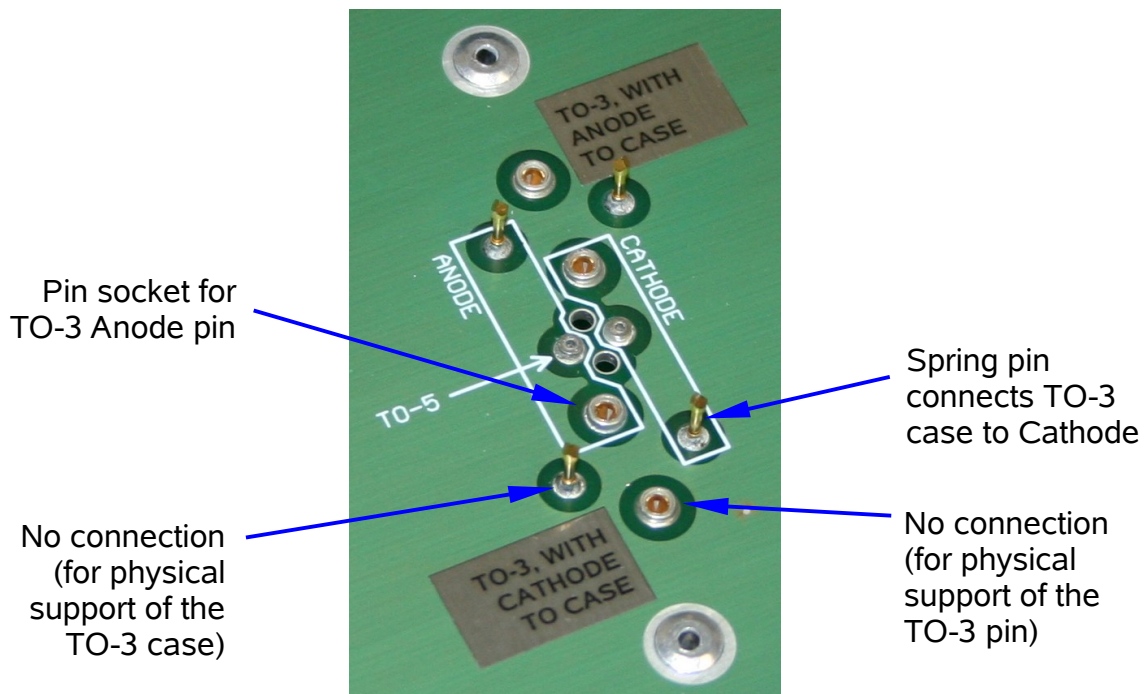
The device pin sockets and spring pins are shown in greater detail below for the TO-5:



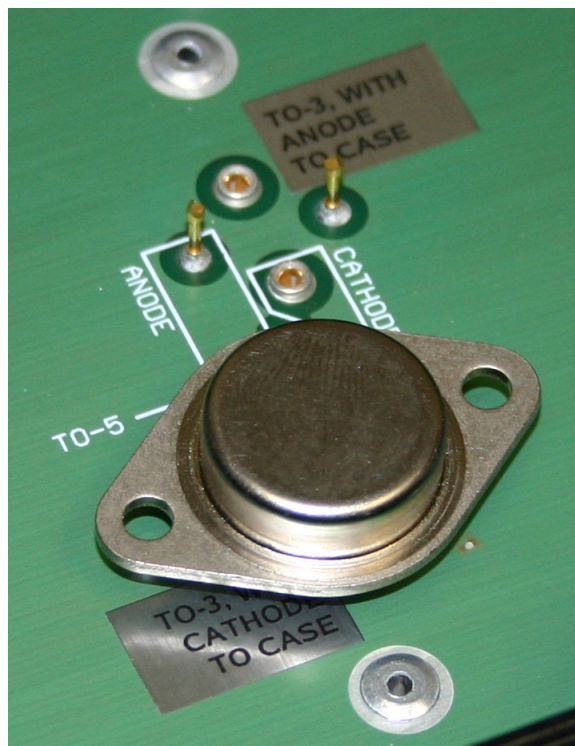
Two pin sockets are provided in the central area to accept the TO-5 package. The unconnected pin passes through one of two clearance hole in the PCB. The Anode and Cathode pin sockets are clearly marked on the PCB. The anode pin socket is on the left, and the cathode is on the right. An example installation is shown below:



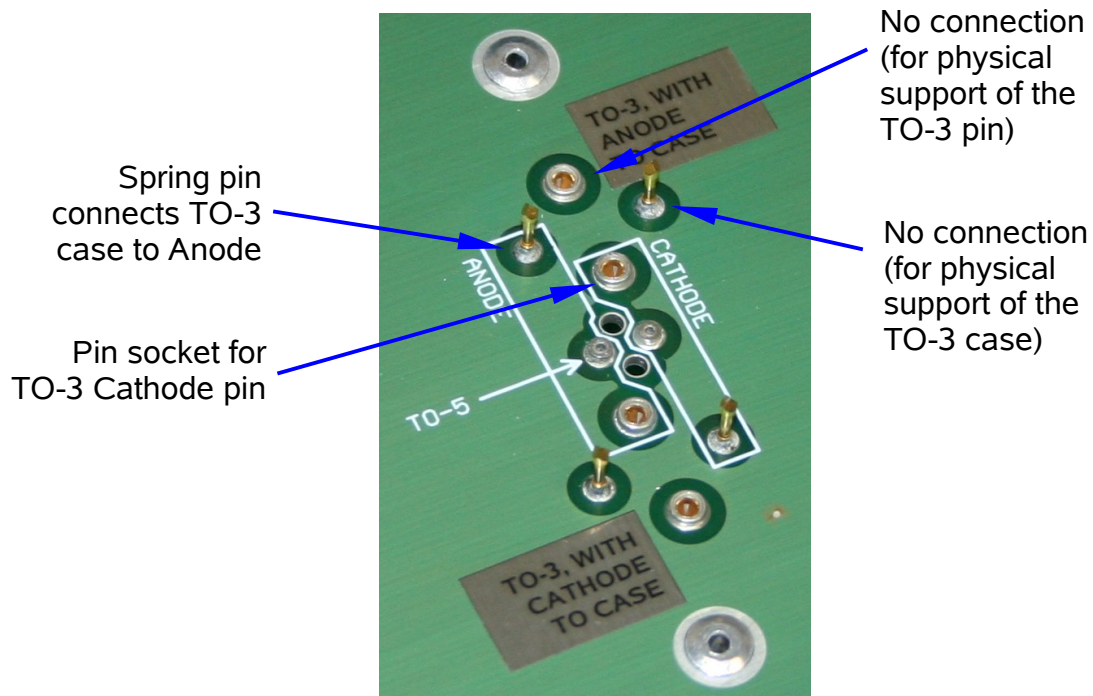
Two TO-3 configuration are possible, one with the case connected to the anode, and one with the case connected to the cathode. For the case-cathode configuration, this layout is used:



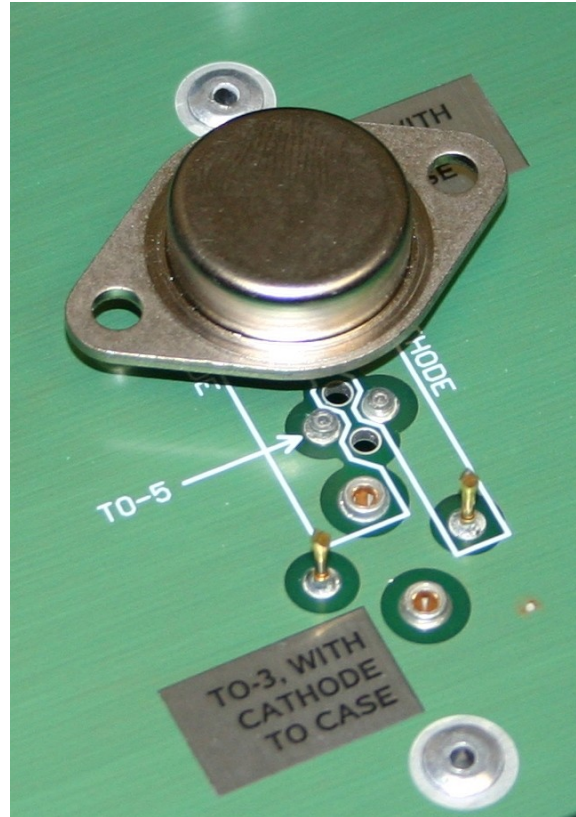
An installed case-cathode device is shown below:



For the case-anode configuration, this layout is used:

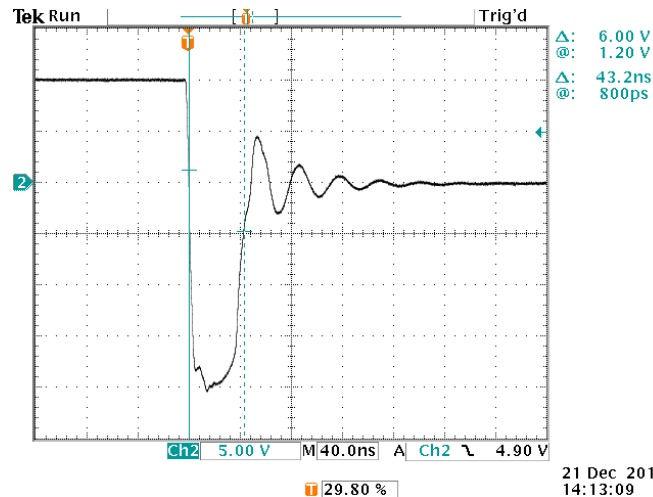


An installed case-anode device is shown below:



Only one of the two pins on the TO-3 package is electrically connected in this jig. This allows testing of dual-diode TO-3 packages, by rotating the package to isolate the desired diode.

The Microsemi UTG8042 is a dual ultrafast rectifier in a TO-3 package, with the cathodes connected to the case. With the amplitudes set to +100V and -200V, the following reverse recovery waveform is obtained at the test jig "OUT" terminal:



5 V/div (= 1 A/div), 40 ns/div.
 20%-80% switching time shown.
 S/N 12584. 60 cm cable used.

The above waveform shows the transition from a forward current of +2A to a reverse current of -4A. The reverse transient lasts for approximately 43 ns under these conditions, and then ends rather abruptly, causing small reflections.

AVX-TRR-AR1 TEST JIG

The AVX-TRR-AR1 test jig has been designed to accept a variety of axial and SQMELF packages. It has been designed specifically to accept:

1. Microsemi "Type E" axial packages (used in the 1N5418 and other devices)
2. Generic DO-41 packages (used in the 1N5819 and other devices)
3. Microsemi Type A square MELF, also called D-5A (for example, 1N5806US)
4. Microsemi Type B square MELF, also called D-5D (for example, 1N6701US)
5. Microsemi Type E square MELF, also called D-5B (for example, 1N5811US)

To install a DUT, open the main (black) lid like this:



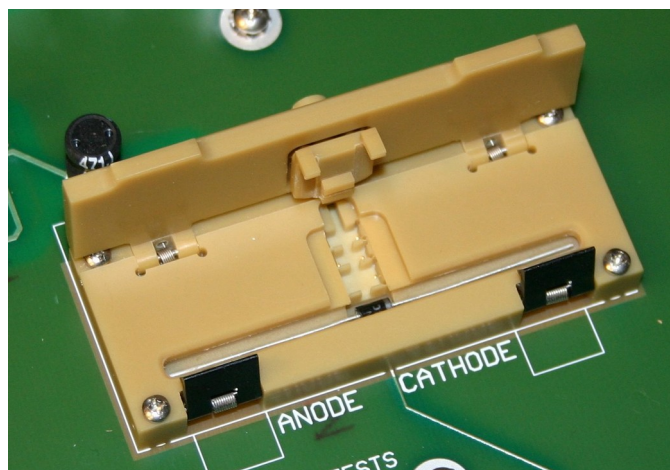
Then open the tan-colored DUT socket by flipping forward the two black latches on the front edge of it:



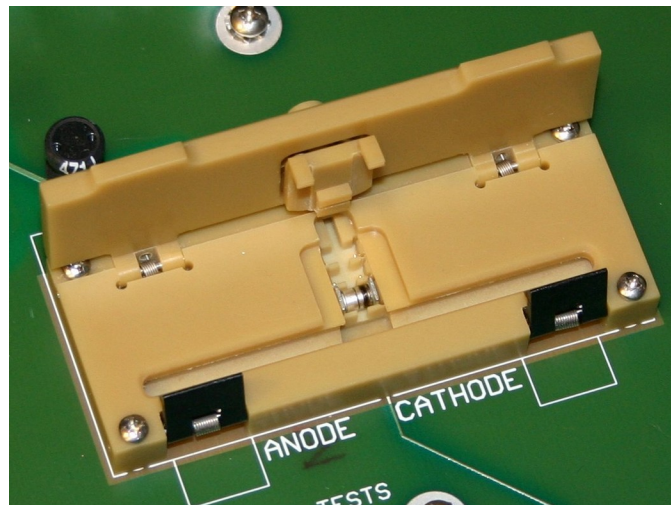
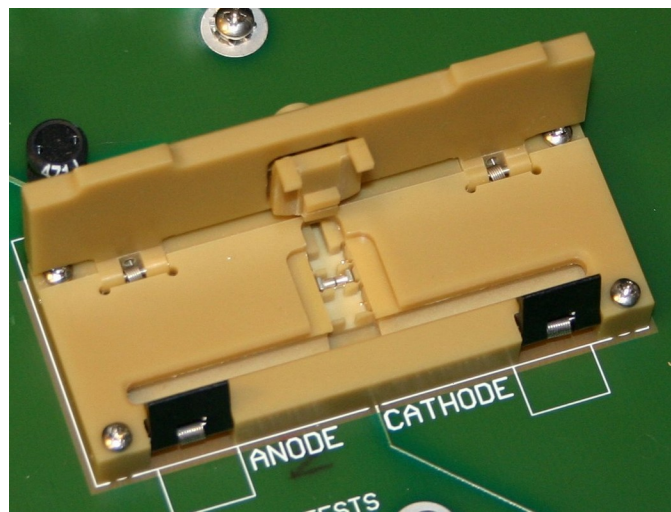
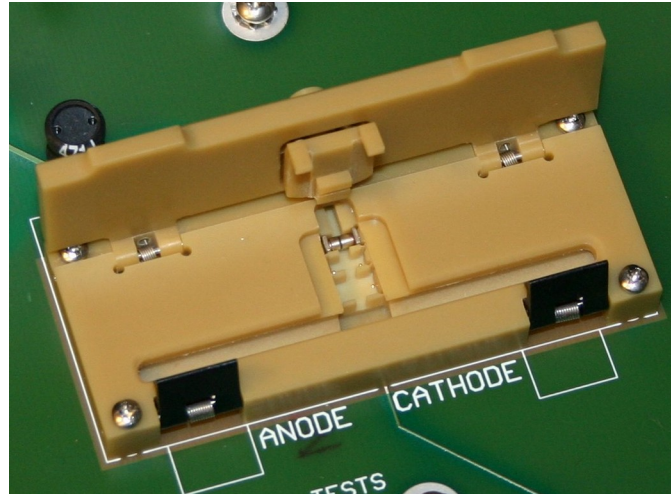
Insert a diode into one of the 4 “pockets”. The two gold contact pins are visible in each pocket; the device must be aligned with these pins. A DO-41 package is shown installed below:



Or, shown in a closer view:



The remaining photos shown the different types of SQMELF packages installed:



The four pockets are wired in parallel. Only one DUT may be installed at a time, or the resulting waveforms will be incorrect.

Once the DUT is installed in the appropriate pocket, close the tan-colored socket lid and the black main lid. Both must be closed for proper operation.

The instrument and the DUT will not be damaged if the diode is installed with the incorrect orientation (i.e., with the anode and cathode reversed). However, incorrect waveforms will be generated.

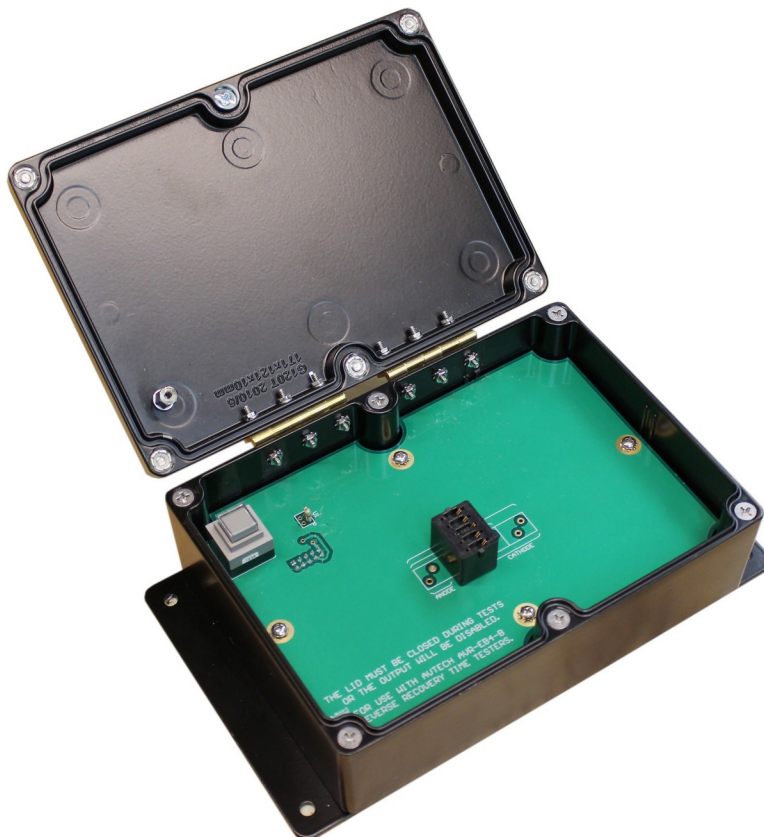
The IN, OUT, and CONTROL connectors are on the rear of the jig, below the hinges:



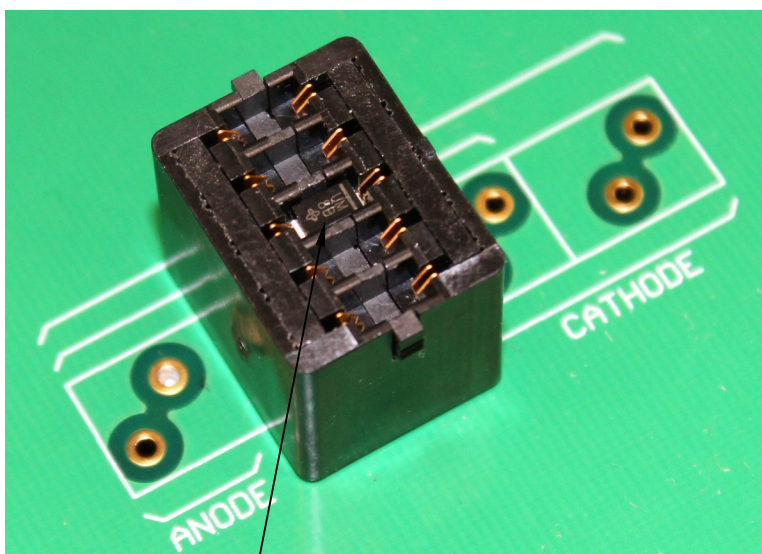
AVX-TRR-DO214AC TEST JIG

The AVX-TRR-DO214AC accepts DO214AC type SMT packages in a Loranger 03481 101 6218 socket. This socket has five identical “pockets” that each accept a DO214AC package. Only one DUT should be installed at a time. All five pockets are wired in parallel, so any of the five pockets can be used.

The test jig is shown below:



The next photo shows a DO214AC device (Vishay US1M) installed in the middle pocket. The anode and cathode sides are clearly marked on the PCB.



A DO214AC-packaged
Device Under Test (DUT)

TROUBLESHOOTING

If you obtain “strange” output waveforms, or unexpected values of t_{RR} , keep these points in mind:

- 1) The test jig output *must* be terminated with 50 Ohms.
- 2) The coaxial cable connecting the test jig to the output module should normally be as short as possible (60 cm or less).
- 3) If the measured t_{RR} seems too long, try reducing the length of the coaxial cable connecting the test jig to the output module as much as possible. (This may or may not affect the measured value, depending on the exact diode switching characteristics.)
- 4) If reflections are observed on the output waveform, increase the length of the coaxial cable connecting the test jig to the output module so that the reflections do not overlap with the reverse transient. This will probably not change the measured value, but it will keep the two effects isolated (the reverse transient and the reflections), for greater measurement confidence.
- 5) Keep device lead lengths as short as possible, to minimize parasitic inductance.
- 6) The test jig lid must be closed, or the pulser output will be disabled.

For technical support, contact info@avtechpulse.com. Sample waveforms and digital photos of your setup are always helpful!

PROGRAMMING YOUR PULSE GENERATOR

KEY PROGRAMMING COMMANDS

The “Programming Manual for -B Instruments” describes in detail how to connect the pulse generator to your computer, and the programming commands themselves. A large number of commands are available; however, normally you will only need a few of these. Here is a basic sample sequence of commands that might be sent to the instrument after power-up:

*rst	(resets the instrument)
trigger:source internal	(selects internal triggering)
frequency 1000 Hz	(sets the frequency to 1000 Hz)
pulse:delay 1 us	(sets the delay to 1 us)
pulse:width1 10 us	(sets the positive pulse width to 10 us)
pulse:width2 5 us	(sets the negative pulse width to 5 us)
volt:ampl1 +100	(sets the positive pulse amplitude to +100 V)
volt:ampl2 -200	(sets the negative pulse amplitude to -200 V)
output on	(turns on the output)

For triggering a single event, this sequence would be more appropriate:

*rst	(resets the instrument)
trigger:source hold	(turns off all triggering)
output on	(turns on the output)
pulse:delay 1 us	(sets the delay to 1 us)
pulse:width1 10 us	(sets the positive pulse width to 10 us)
pulse:width2 5 us	(sets the negative pulse width to 5 us)
volt:ampl1 +100	(sets the positive pulse amplitude to +100 V)
volt:ampl2 -200	(sets the negative pulse amplitude to -200 V)
trigger:source immediate	(generates a single non-repetitive trigger event)
trigger:source hold	(turns off all triggering)
output off	(turns off the output)

To set the instrument to trigger from an external TTL signal applied to the rear-panel TRIG connector, use:

*rst	(resets the instrument)
trigger:source external	(selects external triggering)
pulse:delay 1 us	(sets the delay to 1 us)
pulse:width1 10 us	(sets the positive pulse width to 10 us)
pulse:width2 5 us	(sets the negative pulse width to 5 us)
volt:ampl1 +100	(sets the positive pulse amplitude to +100 V)
volt:ampl2 -200	(sets the negative pulse amplitude to -200 V)
output on	(turns on the output)

These commands will satisfy 90% of your programming needs.

ALL PROGRAMMING COMMANDS

For more advanced programmers, a complete list of the available commands is given below. These commands are described in detail in the “Programming Manual for -B Instruments”. (Note: this manual also includes some commands that are not implemented in this instrument. They can be ignored.)


<u>Keyword</u>	<u>Parameter</u>	<u>Notes</u>
OUTPut:		
:[STATe]	<boolean value>	
:PROTection		
:TRIPped?		[query only]
[SOURce]:		
:FREQuency		
[:CW FIXed]	<numeric value>	
[SOURce]:		
:PULSe		
:PERiod	<numeric value>	
:WIDTh	<numeric value>	
:DELay	<numeric value>	
:GATE		
:LEVel	High Low	
[SOURce]:		
:VOLTage		
[:LEVel]		
[:IMMediate]		
[:AMPLitude]	<numeric value>	
:PROTection		
:TRIPped?		[query only]
STATUS:		
:OPERation		
:[EVENT]?		[query only, always returns "0"]
:CONDition?		[query only, always returns "0"]
:ENABle	<numeric value>	[implemented but not useful]
:QUEStionable		
:[EVENT]?		[query only, always returns "0"]
:CONDition?		[query only, always returns "0"]
:ENABle	<numeric value>	[implemented but not useful]
SYSTEM:		
:COMMunicate		
:GPIB		
:ADDReSS	<numeric value>	
:SERial		
:CONTRol		
:RTS	ON IBFull RFR	
:[RECeive]		
:BAUD	1200 2400 4800 9600 19200 38400 57600 115200	
:ERRor		
:[NEXT]?		[query only]

:COUNT?		[query only]
:VERSion?		[query only]
TRIGger:		
:SOURce	INTernal EXTernal MANual HOLD IMMEDIATE	
*CLS		[no query form]
*ESE	<numeric value>	
*ESR?		[query only]
*IDN?		[query only]
*OPC		
*SAV	0 1 2 3	[no query form]
*RCL	0 1 2 3	[no query form]
*RST		[no query form]
*SRE	<numeric value>	
*STB?		[query only]
*TST?		[query only]
*WAI		[no query form]


MECHANICAL INFORMATION

TOP COVER REMOVAL

If necessary, the interior of the instrument may be accessed by removing the four Phillips screws on the top panel. With the four screws removed, the top cover may be slid back (and off).

 Always disconnect the power cord and allow the instrument to sit unpowered for 10 minutes before opening the instrument. This will allow any internal stored charge to discharge.

There are no user-adjustable internal circuits. For repairs other than fuse replacement, please contact Avtech (info@avtechpulse.com) to arrange for the instrument to be returned to the factory for repair. Service is to be performed solely by qualified service personnel.

 Caution: High voltages are present inside the instrument during normal operation. Do not operate the instrument with the cover removed.

RACK MOUNTING

A rack mounting kit is available. The -R5 rack mount kit may be installed after first removing the one Phillips screw on the side panel adjacent to the front handle.

ELECTROMAGNETIC INTERFERENCE

To prevent electromagnetic interference with other equipment, all used outputs should be connected to shielded loads using shielded coaxial cables. Unused outputs should be terminated with shielded coaxial terminators or with shielded coaxial dust caps, to prevent unintentional electromagnetic radiation. All cords and cables should be less than 3m in length.

MAINTENANCE

REGULAR MAINTENANCE

This instrument does not require any regular maintenance.

On occasion, one or more of the four rear-panel fuses may require replacement. All fuses can be accessed from the rear panel. See the “FUSES” section for details.

CLEANING

If desired, the interior of the instrument may be cleaned using compressed air to dislodge any accumulated dust. (See the “TOP COVER REMOVAL” section for instructions on accessing the interior.) No other cleaning is recommended.

TRIGGER DAMAGE

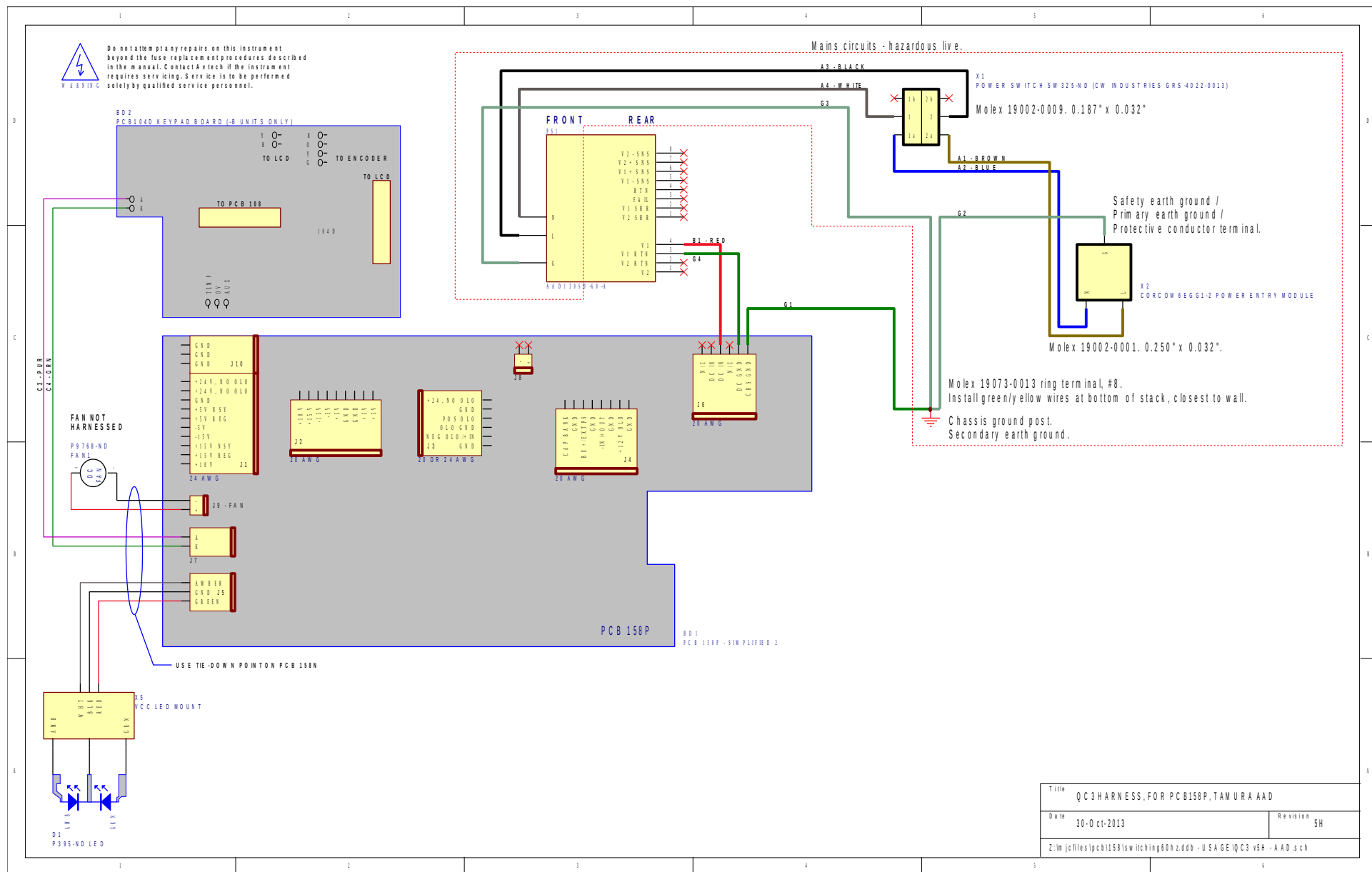
The rear-panel TRIG input, used in the external trigger mode, is protected by a diode clamping circuit. However, the protection circuit is not foolproof, and it is possible for a grossly excessive signal to damage the trigger circuitry on the main timing control board (the 4×10 inch board on the right side of the instrument).

The IC that is most likely to fail under these conditions is installed in a socket. It is a standard TTL IC in a 16-pin plastic DIP package, model 74F151 or equivalent.

If you suspect that this IC has been damaged, turn off the power and replace this IC. It may be replaced by a 74F151, 74LS151, 74ALS151, or 74HCT151.

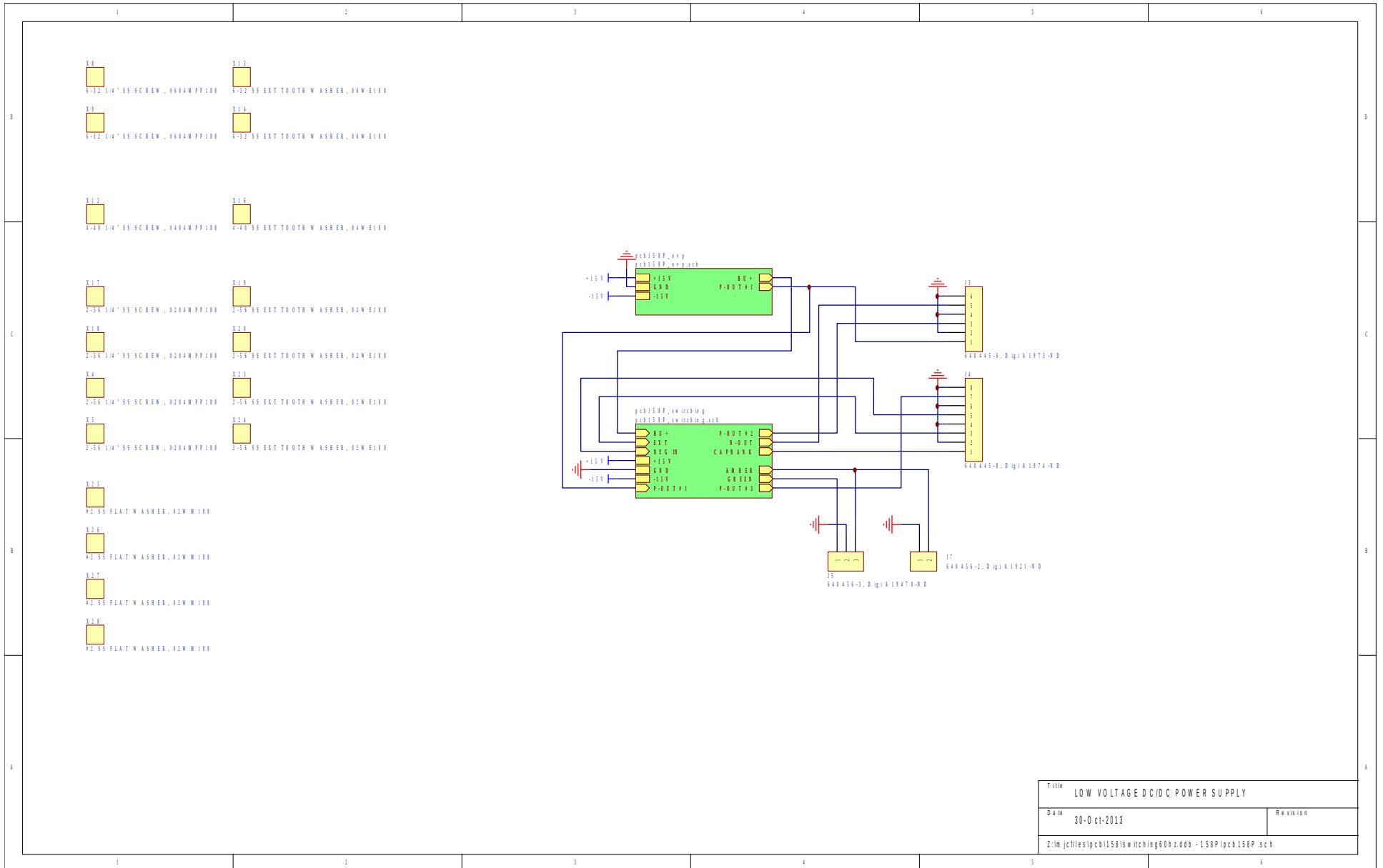
WIRING DIAGRAMS

WIRING OF AC POWER



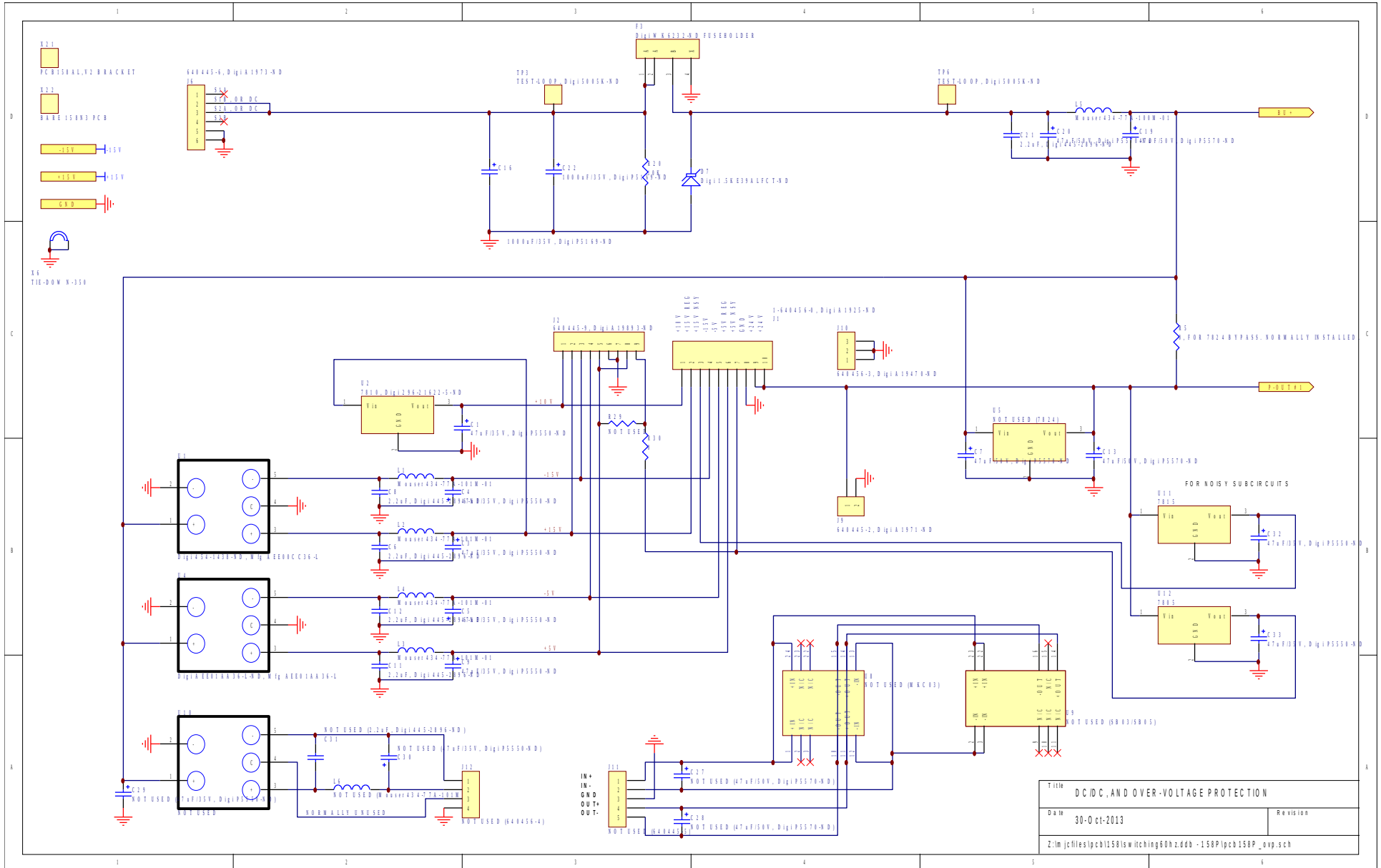
Title: QC3 HARNESS, FOR PCB158P, TAMURA AAD	
Date: 30-Oct-2013	Revision: 5H
Z:\m\jch\files\pcb158p\wiring\60hz.ddb - USA GE IQC3 v5H - AAD.sch	

PCB 158P - LOW VOLTAGE POWER SUPPLY, 1/3



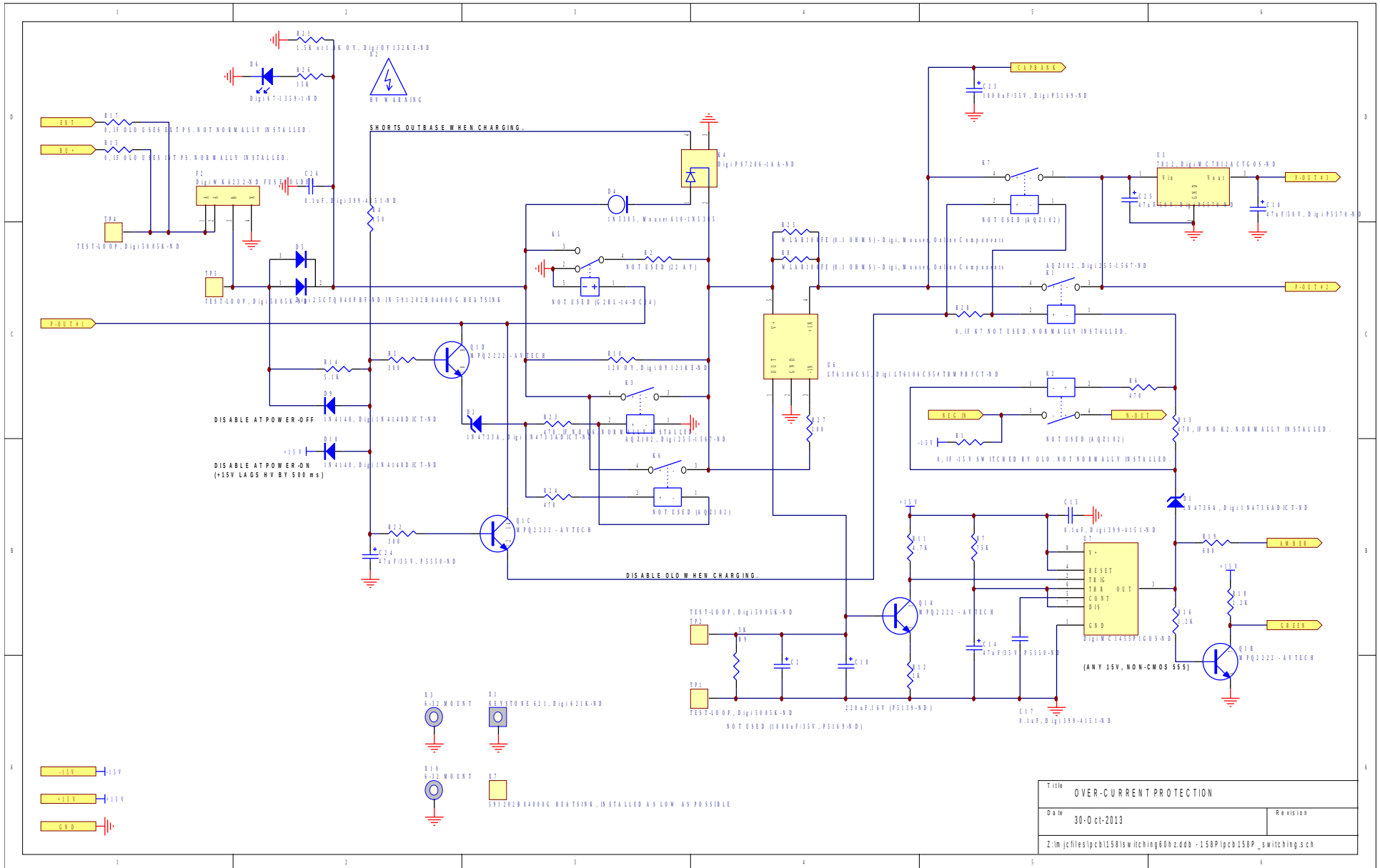
Title		LOW VOLTAGE DC/DC POWER SUPPLY
Date	30-Oct-2013	Revision
Z:\m\jcf\files\pcb158\sw\hchng60hz.ddb - 158P\pcb 158P.sch		

PCB 158P - LOW VOLTAGE POWER SUPPLY, 2/3

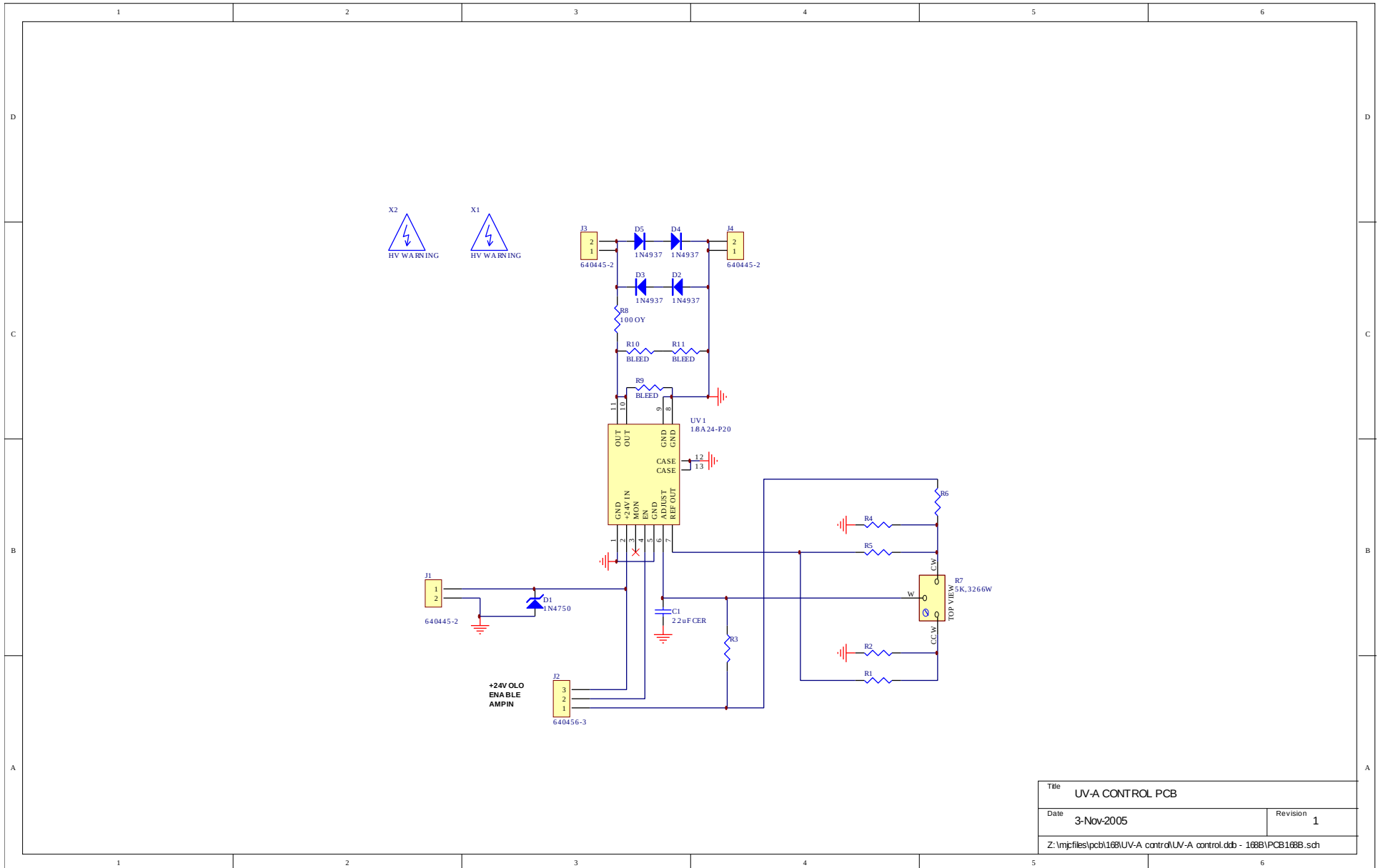


Title		
DC/DC, AND OVER-VOLTAGE PROTECTION		
Date	30-Oct-2013	Revision
Z:\m\jctiles\pcb158\isw\hchng\60h2.ddd - 158P\pcb158P_vxp.sch		

PCB 158P - LOW VOLTAGE POWER SUPPLY, 3/3

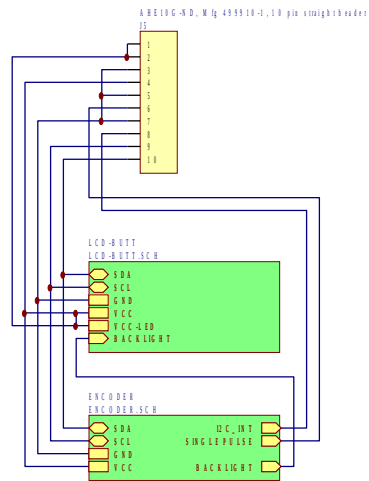


PCB 168B - HIGH VOLTAGE DC POWER SUPPLY



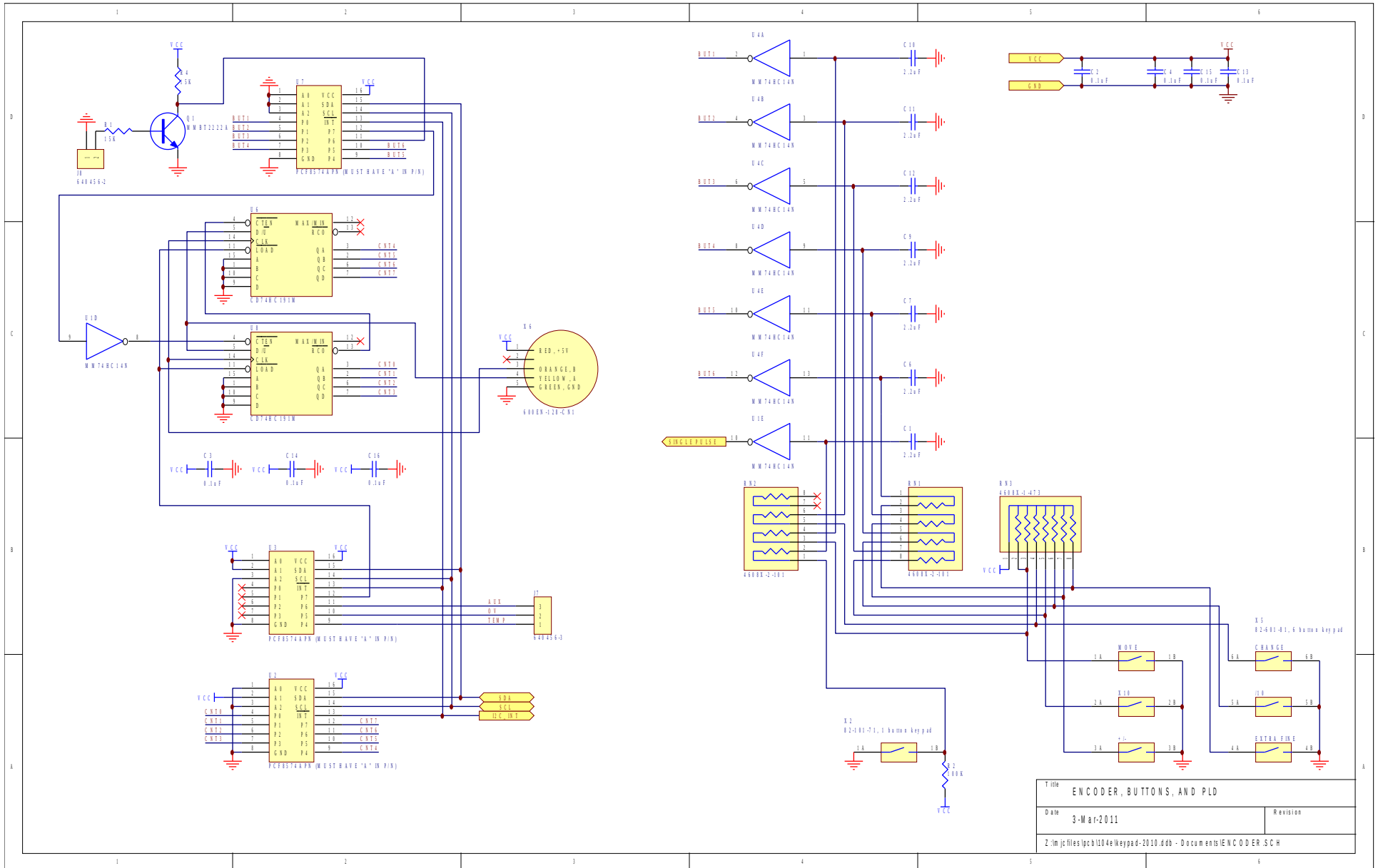
Title UV-A CONTROL PCB	
Date 3-Nov-2005	Revision 1
Z:\mpjfiles\pcb168\UV-A control\UV-A control.ddb - 168B\PCB168B.sch	

PCB 104E - KEYPAD / DISPLAY BOARD, 1/3

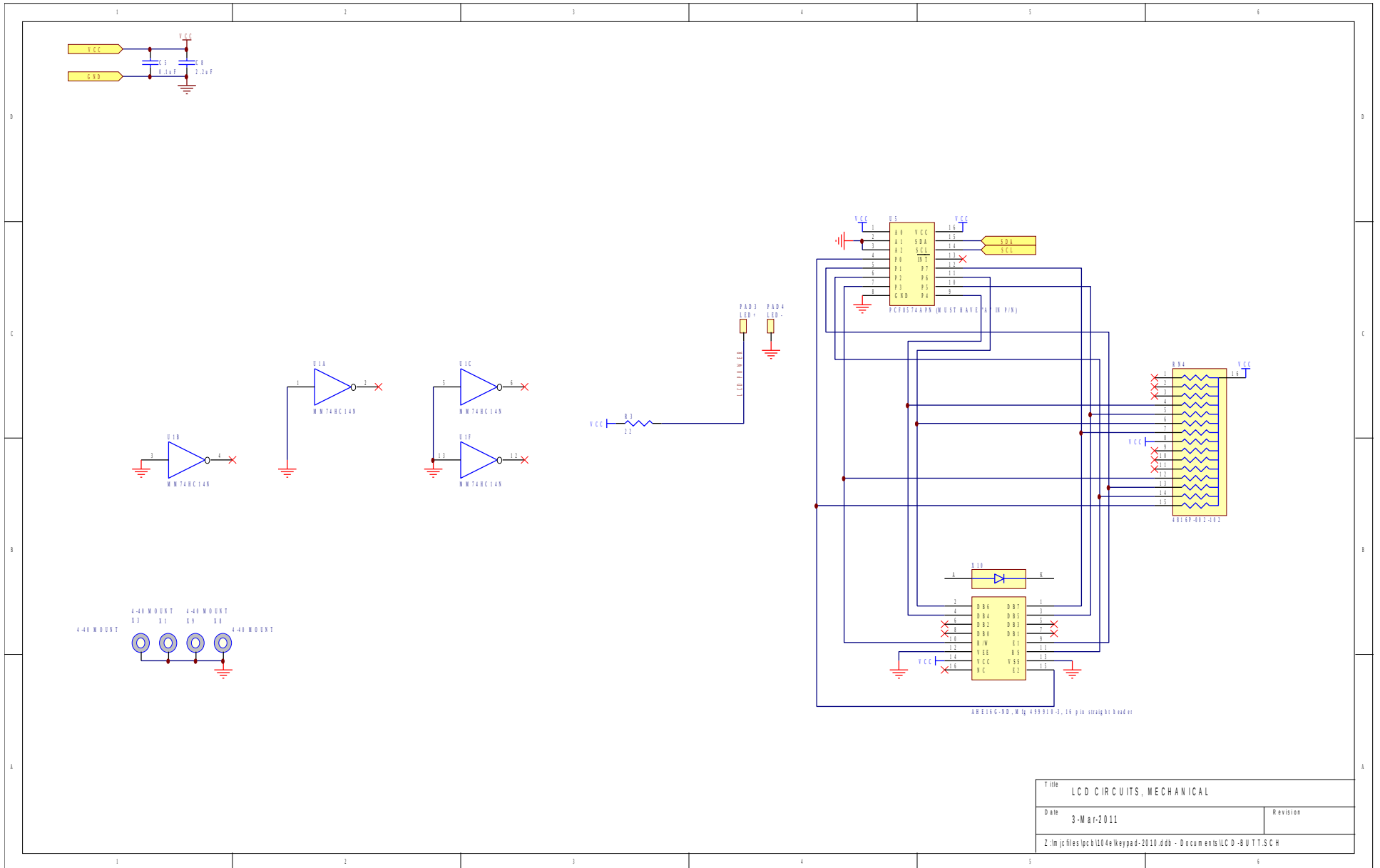


Title		PANEL TOP-LEVEL SCHEMATIC	
Date	3-Mar-2011	Revision	
Z:\m\jc\files\pcb\104e\keypad-2010.ddb - Documents\Panel\rd.pjt			

PCB 104E - KEYPAD / DISPLAY BOARD, 2/3

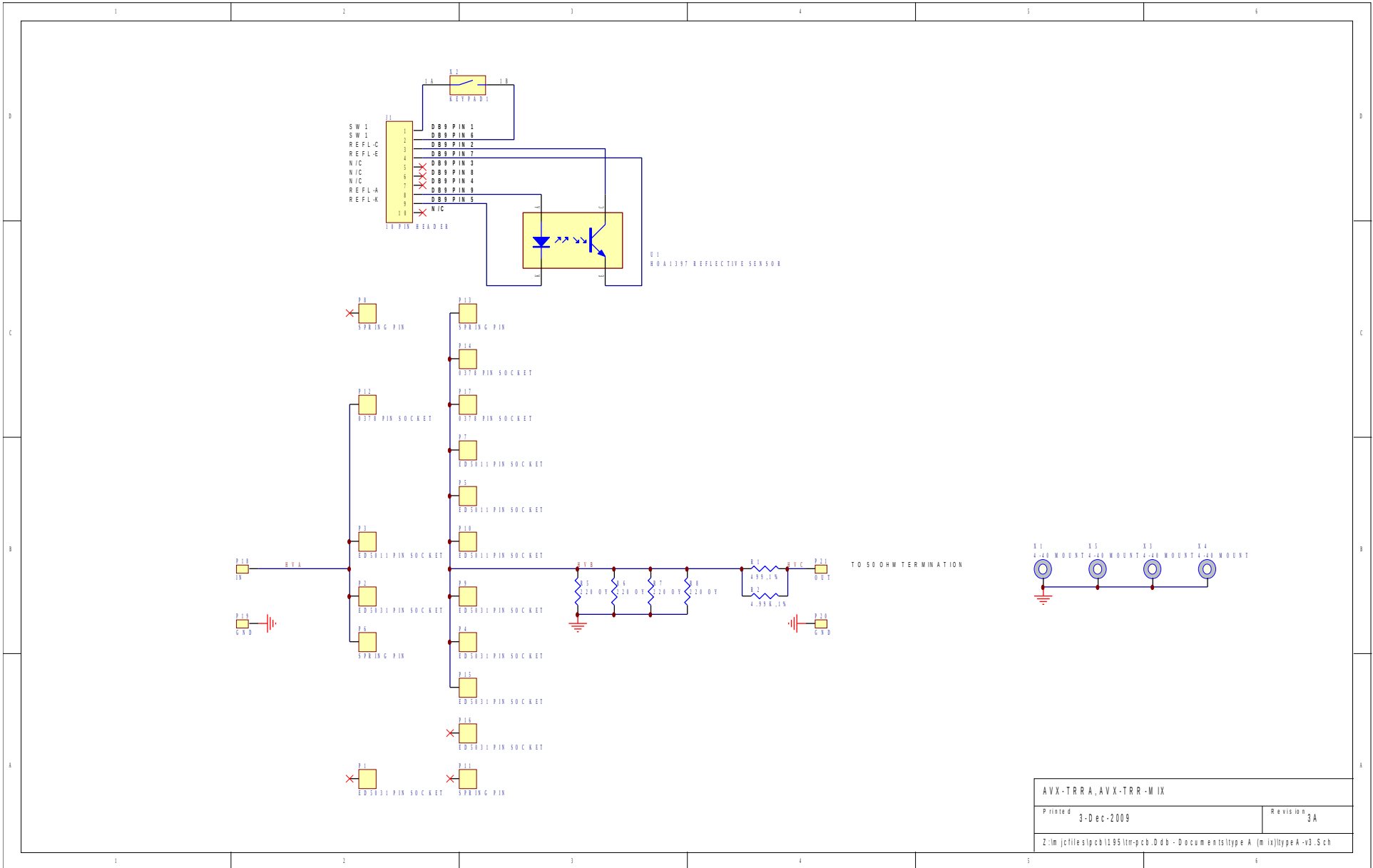


PCB 104E - KEYPAD / DISPLAY BOARD, 3/3



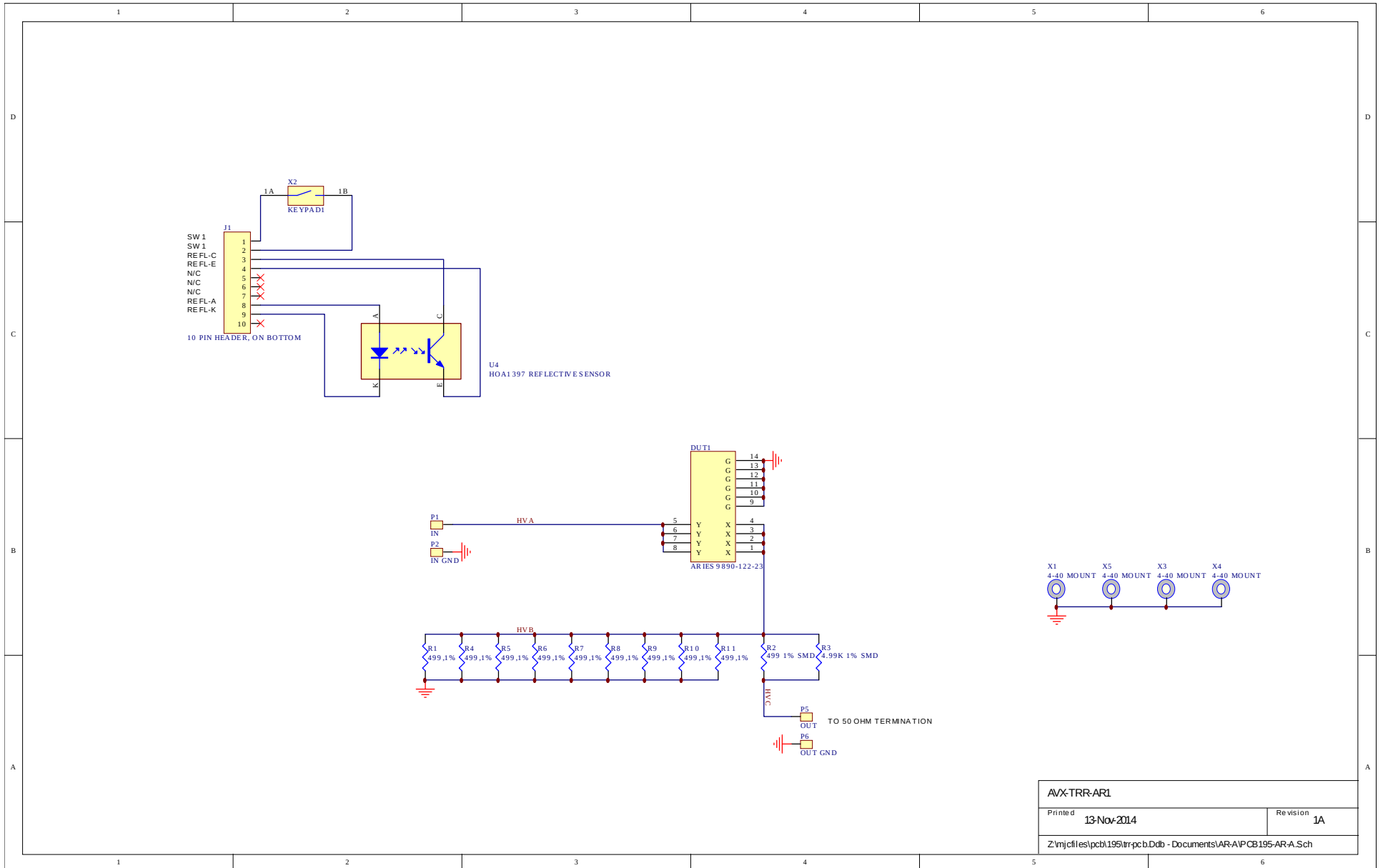
Title LCD CIRCUITS, MECHANICAL	
Date 3-Mar-2011	Revision
Z:\m\j\files\pcb\104e\keypad-2010.ddb - Documents\LCD-BUTTON.SCH	

STANDARD TEST JIG WIRING (AVX-TRR-MIX)



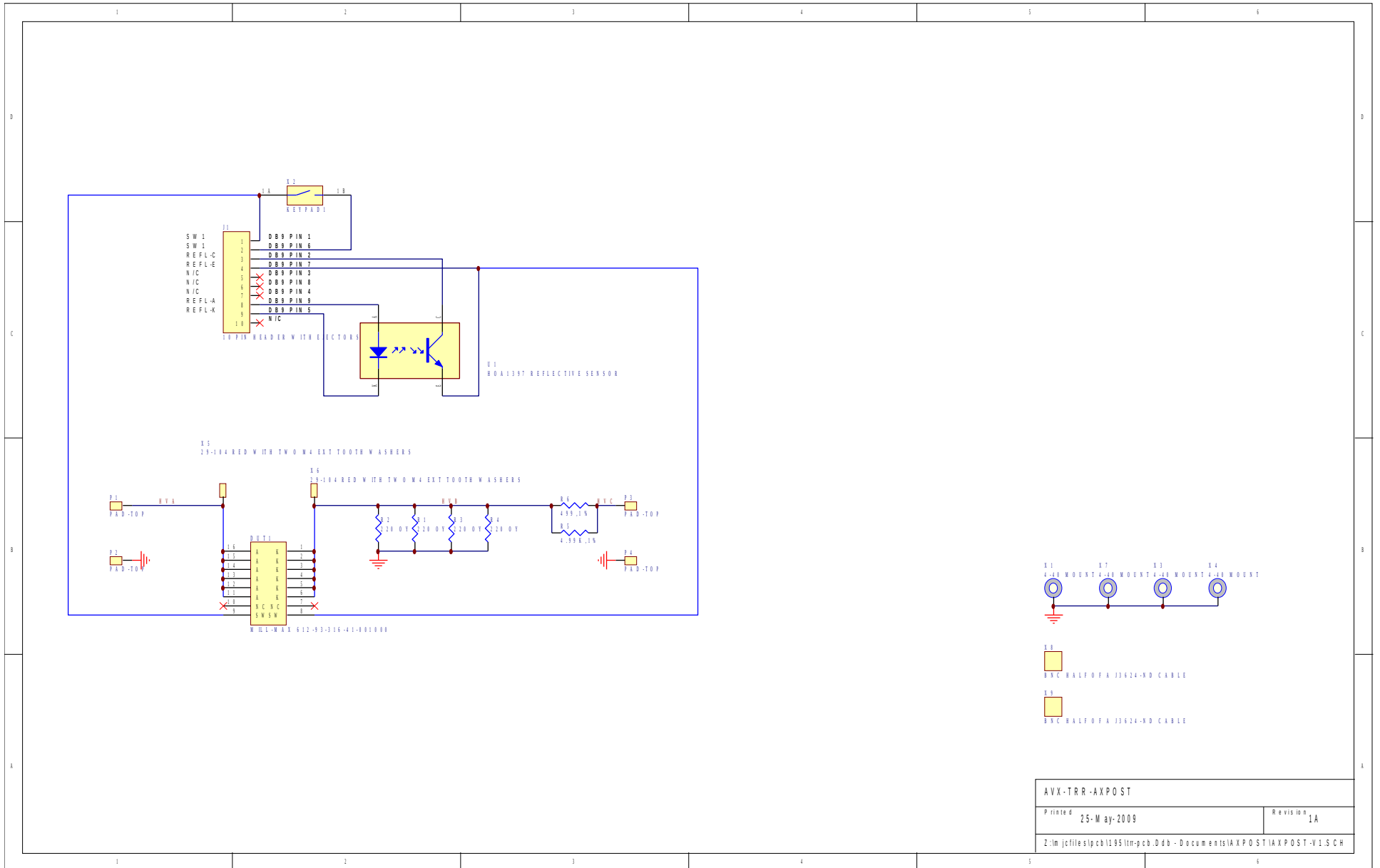
AVX-TRRA, AVX-TRR-MIX	
Printed 3-Dec-2009	Revision 3A
Z:\m\jcf\files\pcb\1285\trr-pcb.DDD - Documents\type A (m rx)\type A-r3.Sch	

TEST JIG WIRING (AVX-TRR-AR1)



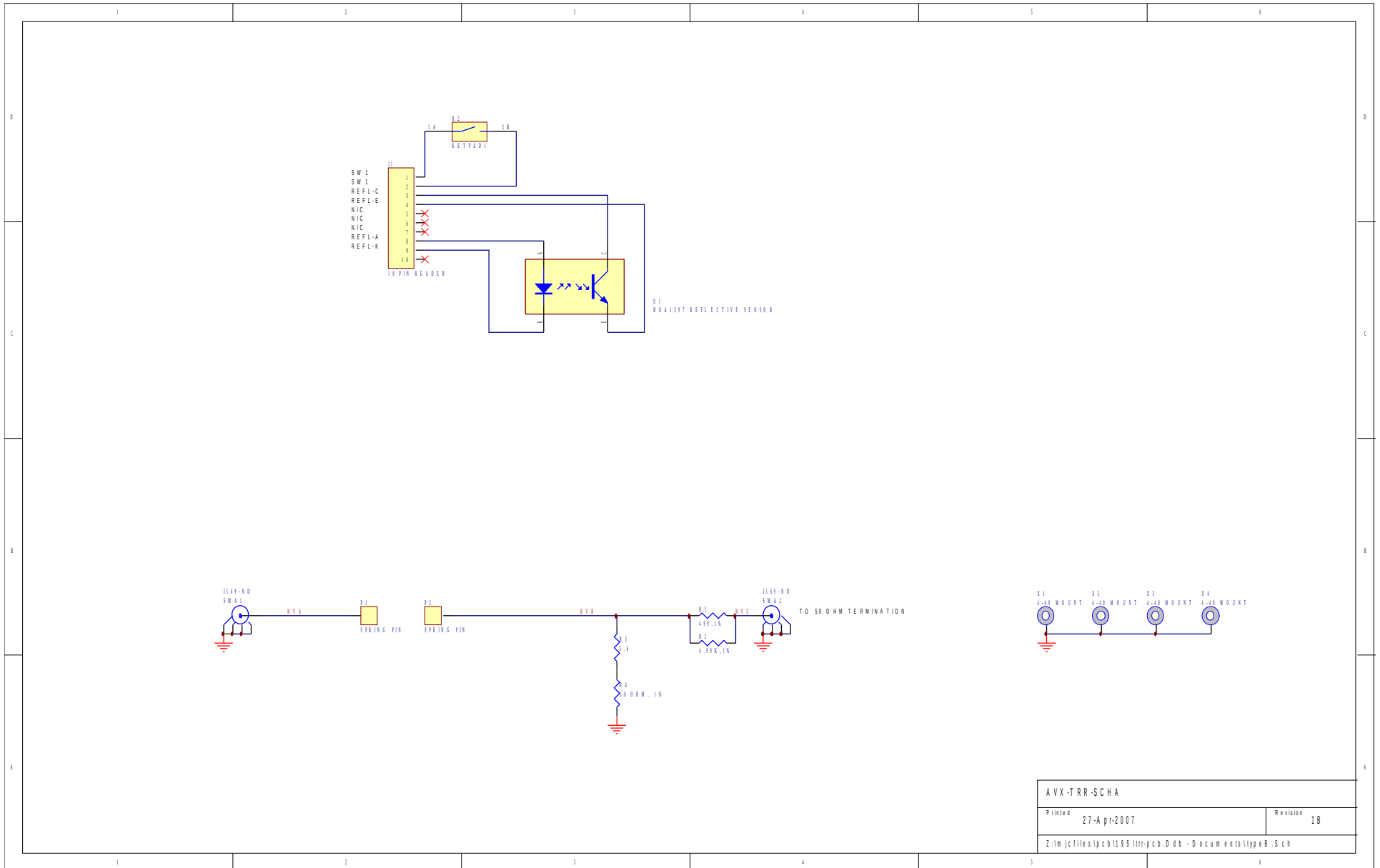
AVX-TRR-AR1	
Printed 13-Nov-2014	Revision 1A
Z:\njc\files\pcb\195\tr-pc.b.Ddb - Documents\AR-A\PCB195-AR-A.Sch	

TEST JIG WIRING (AVX-TRR-AXPOST)

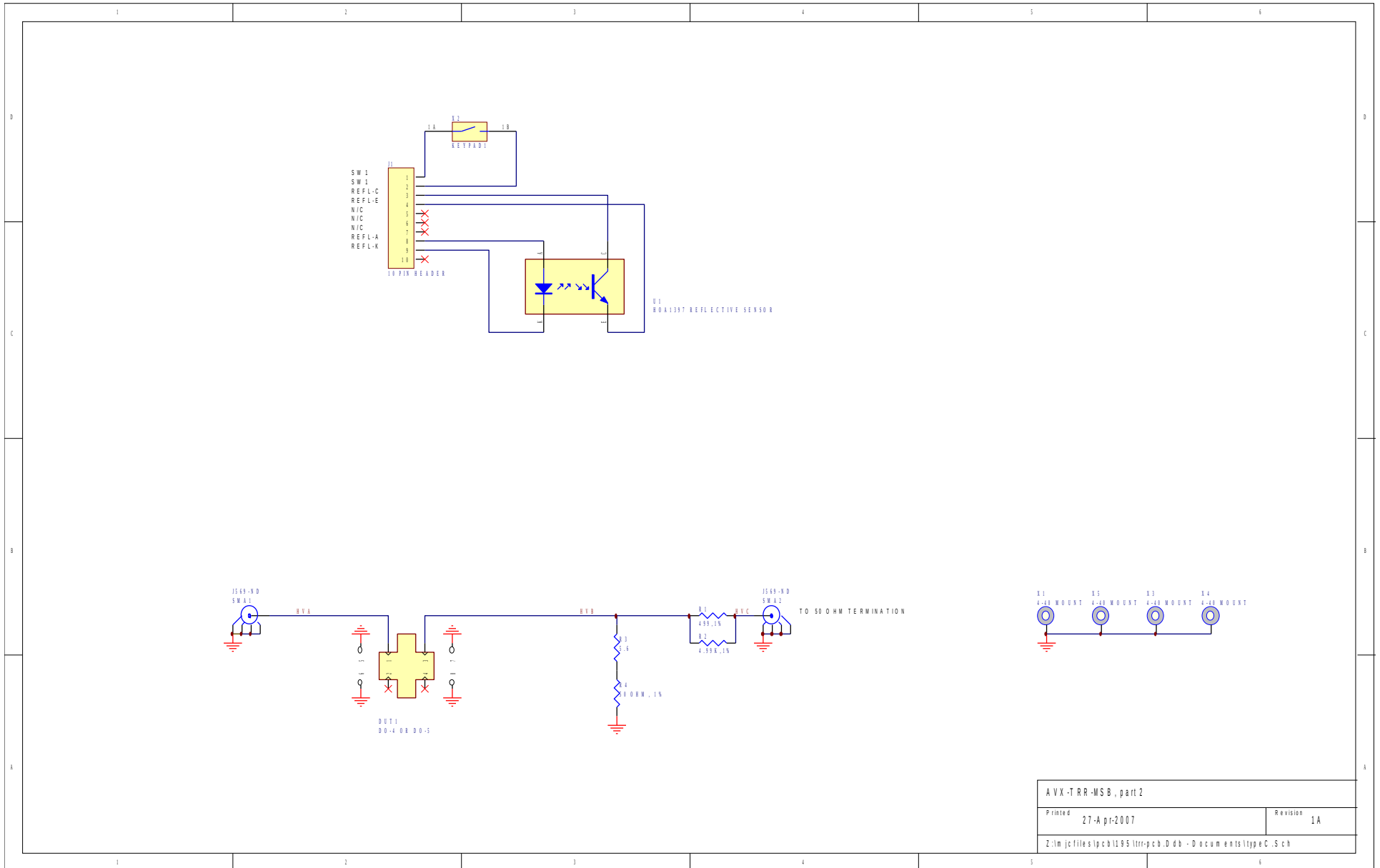


AVX-TRR-AXPOST	
Printed 25-May-2009	Revision 1A
Z:\m\jcf\files\pcb\1295\trr-pcb.DDD - Documents\AXPOST\AXPOST-V1.SCH	

TEST JIG WIRING (AVX-TRR-SCHA / AVX-TRR-MSB-MELF)

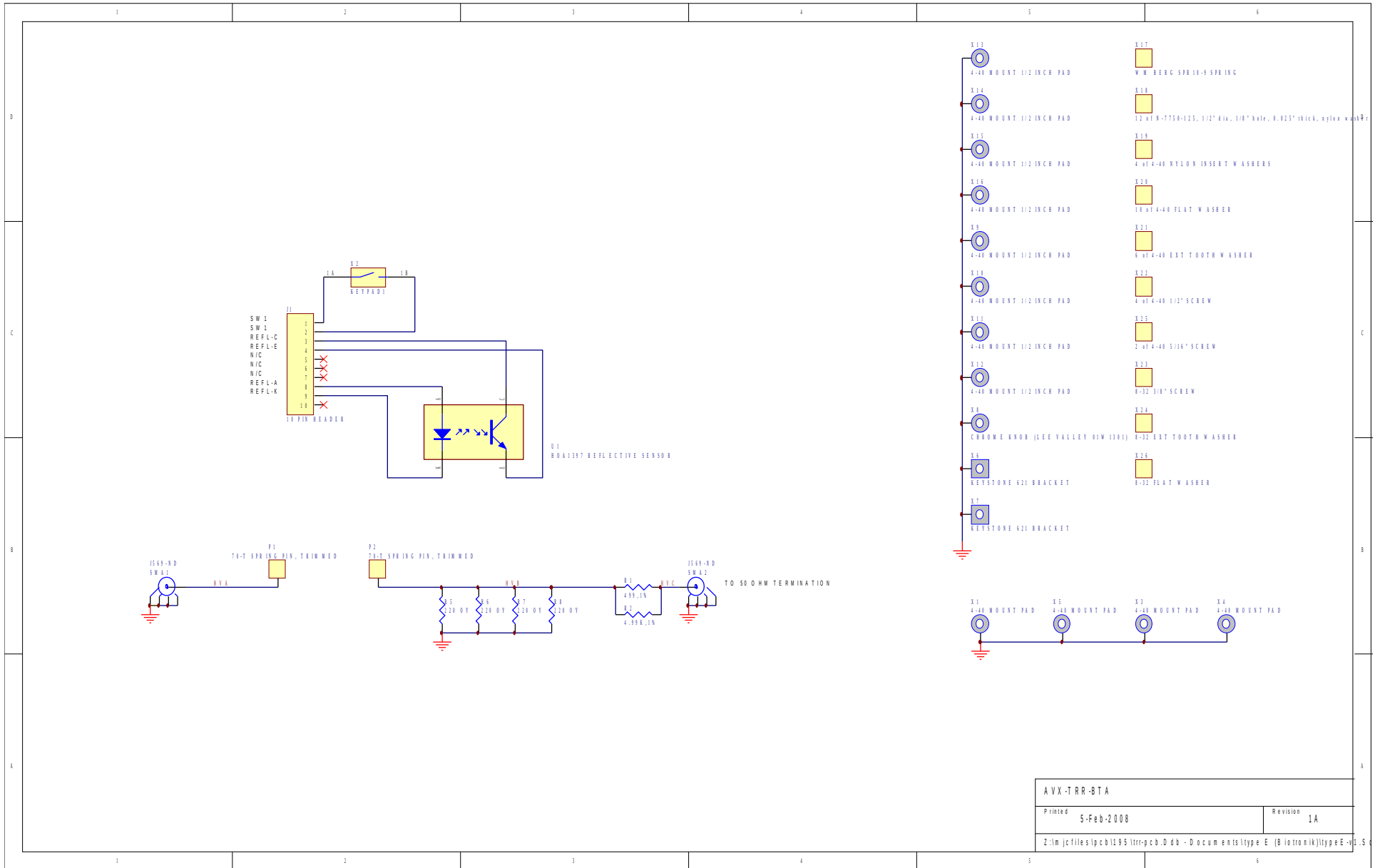


TEST JIG WIRING (AVX-TRR-SCHA / AVX-TRR-MSB-STUD)

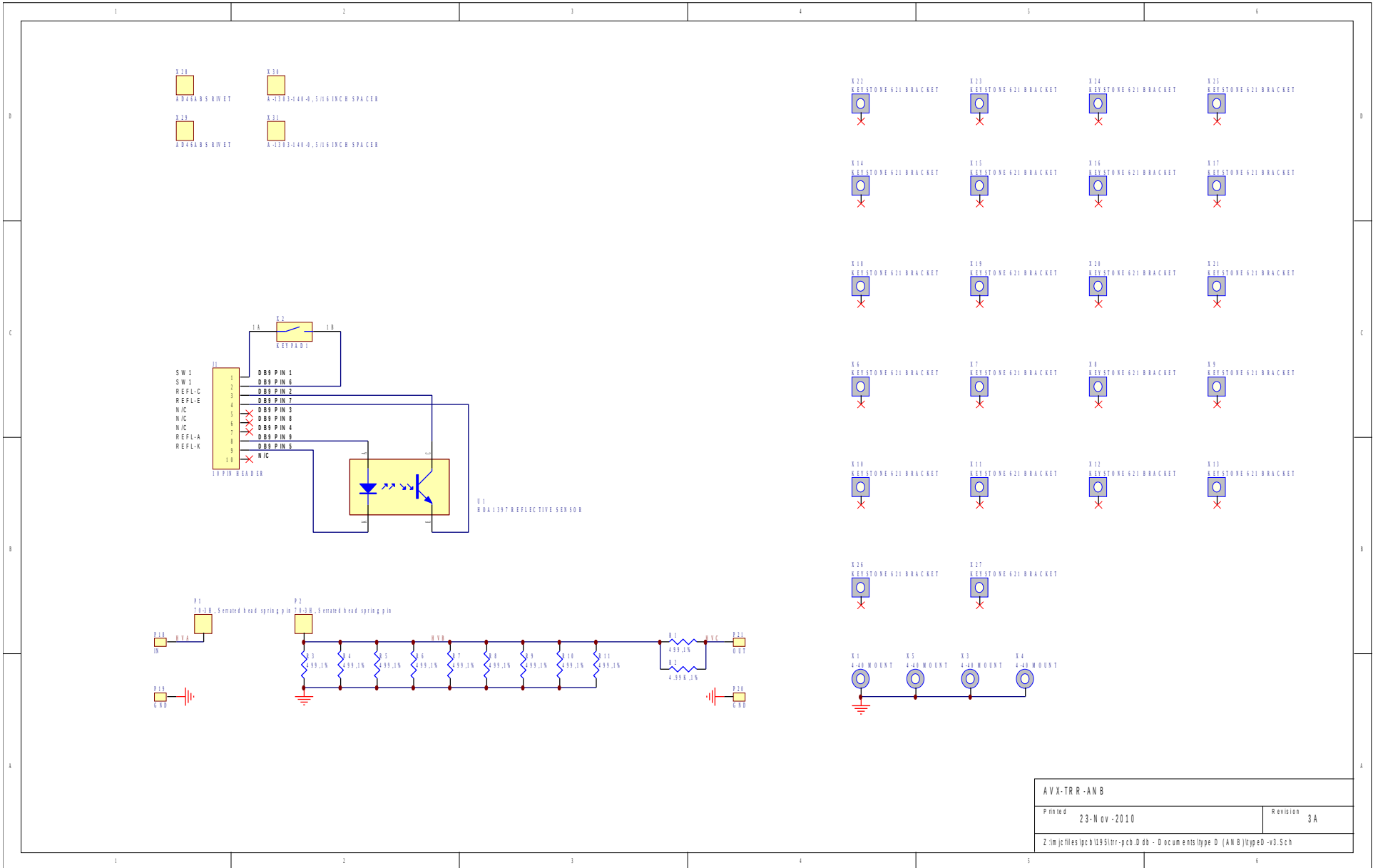


AVX-TRR-MSB, part 2	
Printed 27-Apr-2007	Revision 1A
Z:\m\jc\files\pcb\1195\trr-pcb.Ddb - Documents\typeC.Sch	

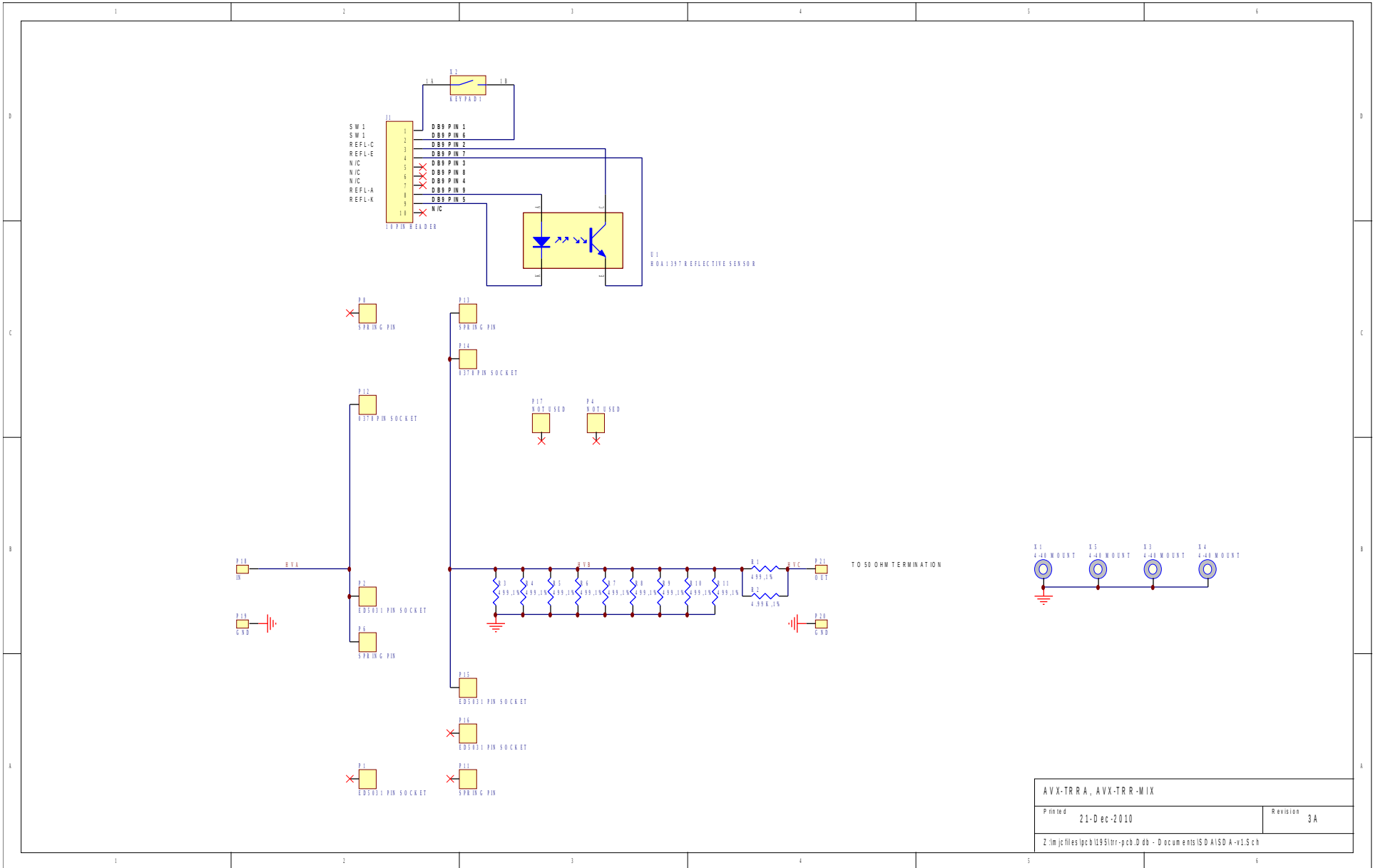
TEST JIG WIRING (AVX-TRR-BTA)



TEST JIG WIRING (AVX-TRR-ANB)

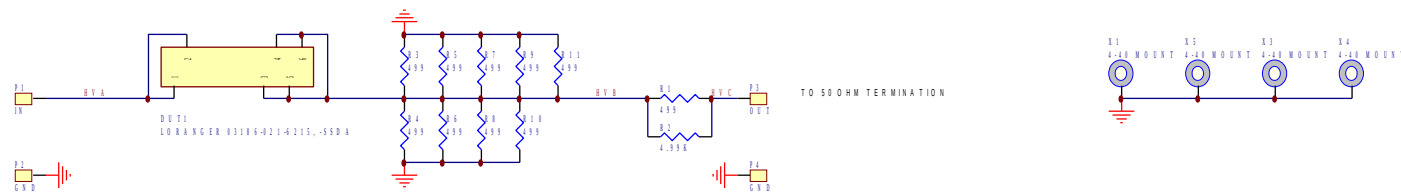
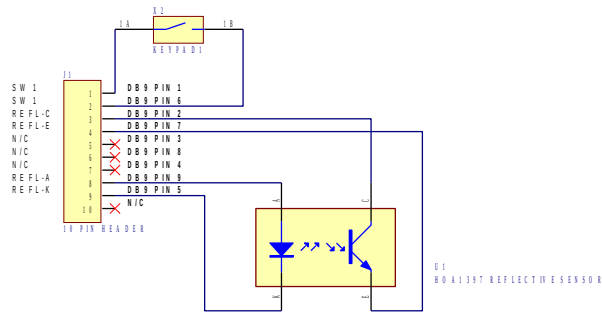


TEST JIG WIRING (AVX-TRR-SDA)



AVX-TRR-A, AVX-TRR-MIX	
Printed 21-Dec-2010	Revision 3A
Z:\m\jcs\files\pcb\12951trr-pcb.dwg - Documents\SDA\SDA-v1.Sch	

TEST JIG WIRING (AVX-TRR-LORAX, AVX-TRR-SDDA, AVX-TRR-DO214AC)



AVX-TRR-LORAX, AVX-TRR-SDDA	
Printed 25-Sep-2013	Revision 2A
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PERFORMANCE CHECK SHEET